

BNZ-A-CAB-02/21-102

TEST REPORT

Test report no.: 1-5618_22-01-11

Testing laboratory

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Accredited Testing Laboratory:

The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2018-03) by the Deutsche Akkreditierungsstelle GmbH (DAKKS)

The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate starting with the registration number: D-PL-12076-01.

Applicant

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Manufacturer

FLIR Systems AB

Antennvägen 6

187 66 Täby / SWEDEN

Test standard/s

FCC - Title 47 CFR Part 15

FCC - Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices

RSS - 247 Issue 2

Digital Transmission Systems (DTSs), Frequency Hopping Systems (FHSs) and Licence - Exempt Local Area Network (LE-LAN) Devices

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item: Handheld Camera

Model name: FLIR-E1330

FCC ID: ZLV-FLIRE1330

ISED certification number: 5306A-FLIRE1330

Frequency: 5150 MHz to 5250 MHz

Technology tested: WLAN

Antenna: Integrated antenna

Power supply: 3.7 V DC by Li-ion battery

Temperature range: -15°C to +40°C

This test report is electronically signed and valid without handwritten signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

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2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CTC advanced GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.

The test report may only be reproduced or published in full. Reproduction or publication of extracts from the report requires the prior written approval of CTC advanced GmbH.

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In no case this test report can be considered as a Letter of Approval.

This test report is electronically signed and valid without handwritten signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

2.2 Application details

Date of receipt of order: 2023-01-30

Date of receipt of test item: 2023-05-02

Start of test:* 2023-05-02

End of test:* 2023-05-11

Person(s) present during the test: -/-

*Date of each measurement, if not shown in the plot, can be requested. Dates are stored in the measurement software.

2.3 Test laboratories sub-contracted

None

3 Test standard/s, references and accreditations

Test standard	Date	Description
FCC - Title 47 CFR Part 15		FCC - Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 247 Issue 2	February 2017	Digital Transmission Systems (DTSS), Frequency Hopping Systems (FHSS) and Licence - Exempt Local Area Network (LE-LAN) Devices
RSS - Gen Issue 5 incl. Amendment 1 & 2	February 2021	Spectrum Management and Telecommunications Radio Standards Specification - General Requirements for Compliance of Radio Apparatus

Guidance	Version	Description
KDB 789033 D02	v02r01	Guidelines for Compliance Testing of Unlicensed National Information Infrastructure (U-NII) Devices - Part 15, Subpart E
ANSI C63.4-2014	-/-	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz
ANSI C63.10-2013	-/-	American National Standard of Procedures for Compliance Testing of Unlicensed Wireless Devices

Accreditation	Description
D-PL-12076-01-04	Telecommunication and EMC Canada https://www.dakks.de/as/ast/d/D-PL-12076-01-04e.pdf
D-PL-12076-01-05	Telecommunication FCC requirements https://www.dakks.de/as/ast/d/D-PL-12076-01-05e.pdf



Deutsche
Akkreditierungsstelle
D-PL-12076-01-04



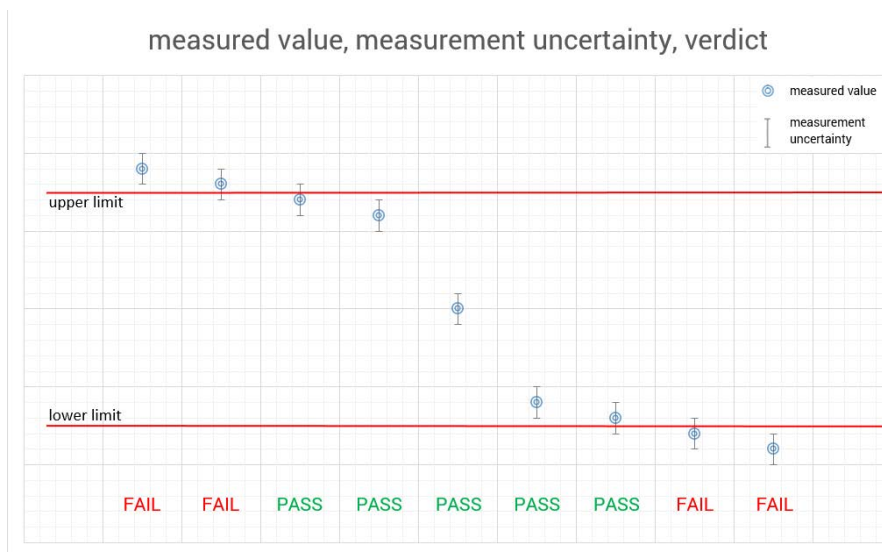
Deutsche
Akkreditierungsstelle
D-PL-12076-01-05

ISED Testing Laboratory Recognized Listing Number: DE0001
FCC designation number: DE0002

4 Reporting statements of conformity – decision rule

Only the measured values related to their corresponding limits will be used to decide whether the equipment under test meets the requirements of the test standards listed in chapter 3.

The measurement uncertainty is mentioned in this test report, see chapter 9, but is not taken into account - neither to the limits nor to the measurement results. Measurement results with a smaller margin to the corresponding limits than the measurement uncertainty have a potential risk of more than 5% that the decision might be wrong."



5 Test environment

Temperature :	T _{nom} T _{max} T _{min}	+22 °C during room temperature tests No testing under extreme temperature conditions required. No testing under extreme temperature conditions required.
Relative humidity content :		55 %
Barometric pressure :		Not relevant for this kind of measurement
Power supply :	V _{nom} V _{max} V _{min}	3.65 V DC by Li-ion battery No testing under extreme voltage conditions required. No testing under extreme voltage conditions required.

6 Test item

6.1 General description

Kind of test item :	Handheld Camera
Model name :	FLIR-E1330
HMN :	N/A
PMN :	E5 Pro, E6 Pro, E8 Pro
HVIN :	FLIR-E1330
FVIN :	N/A
S/N serial number :	Conducted: Prot. 2.12 13300026 Radiated: Prot. 2.11 13300025
Hardware status :	T3006245
Software status :	0.4.4.
Firmware status :	qca9377-lea-3-0-qca_oem-r3000038.3
Frequency band :	5150 MHz to 5250 MHz
Type of radio transmission :	OFDM
Use of frequency spectrum :	
Type of modulation :	(D)BPSK, (D)QPSK, 16 – QAM, 64 – QAM
Number of channels :	4 (20MHz)
Antenna :	Integrated antenna 7.7dBi as declared by the customer
Power supply :	3.65 V DC by Li-ion battery
Temperature range :	-15°C to +40°C

6.2 Additional information

The content of the following annexes is defined in the QA. It may be that not all of the listed annexes are necessary for this report, thus some values in between may be missing.

Test setup and EUT photos are included in test report: 1-5618_22-01-10_AnnexA
1-5618_22-01-10_AnnexB
1-5618_22-01-10_AnnexD

7 Description of the test setup

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, RF generating and signaling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

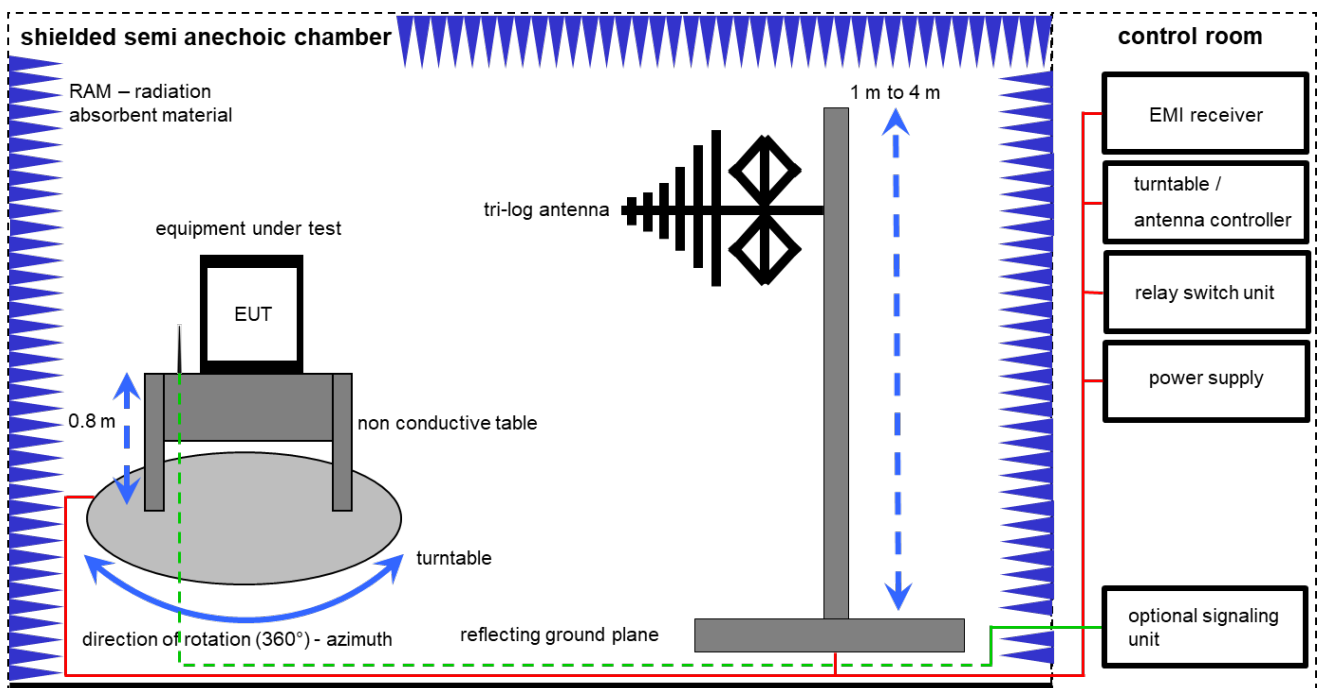
Each block diagram listed can contain several test setup configurations. All devices belonging to a test setup are identified with the same letter syntax. For example: Column Setup and all devices with an A.

Agenda: Kind of Calibration

k	calibration / calibrated	EK	limited calibration
ne	not required (k, ev, izw, zw not required)	zw	cyclical maintenance (external cyclical maintenance)
ev	periodic self verification	izw	internal cyclical maintenance
Ve	long-term stability recognized	g	blocked for accredited testing
vlk!	Attention: extended calibration interval		
NK!	Attention: not calibrated	*)	next calibration ordered / currently in progress

7.1 Shielded semi anechoic chamber

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 30 MHz to 1 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are conform to specifications ANSI C63. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analyzers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63.



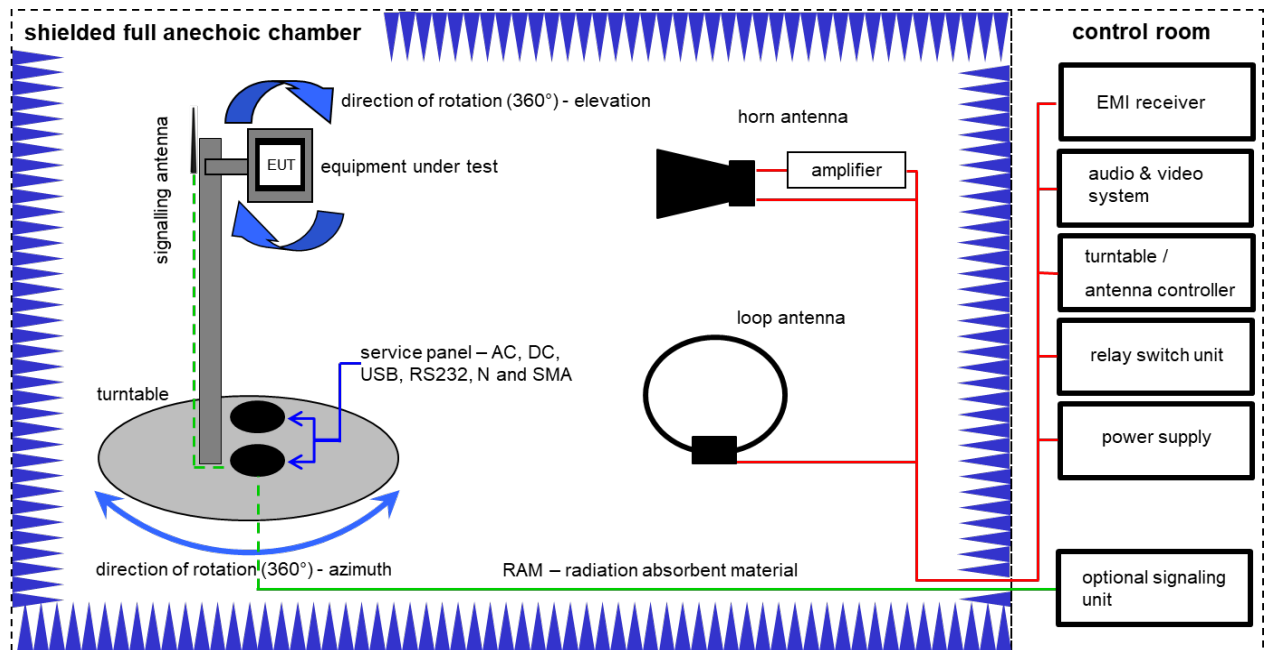
Measurement distance: tri-log antenna 10 meter

EMC32 software version: 10.59.00

Equipment table:

No.	Setup	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Switch-Unit	3488A	HP	2719A14505	300000368	ev	-/-	-/-
2	A	Semi anechoic chamber	3000023	MWB AG		300000551	ne	-/-	-/-
3	A	Antenna Tower	Model 2175	ETS-Lindgren	64762	300003745	izw	-/-	-/-
4	A	Positioning Controller	Model 2090	ETS-Lindgren	64672	300003746	izw	-/-	-/-
5	A	Turntable Interface-Box	Model 105637	ETS-Lindgren	44583	300003747	izw	-/-	-/-
6	A	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck Mess-Elektronik	318	300003696	vKI!	30.09.2021	29.09.2023
7	A	Turntable	2089-4.0	EMCO		300004394	ne	-/-	-/-
8	A	PC	TecLine	F+W		300004388	ne	-/-	-/-
9	A	EMI Test Receiver	ESR3	Rohde & Schwarz	102587	300005771	k	09.12.2022	31.12.2023

7.2 Shielded fully anechoic chamber



Measurement distance: horn antenna 3 meter; loop antenna 3 meter

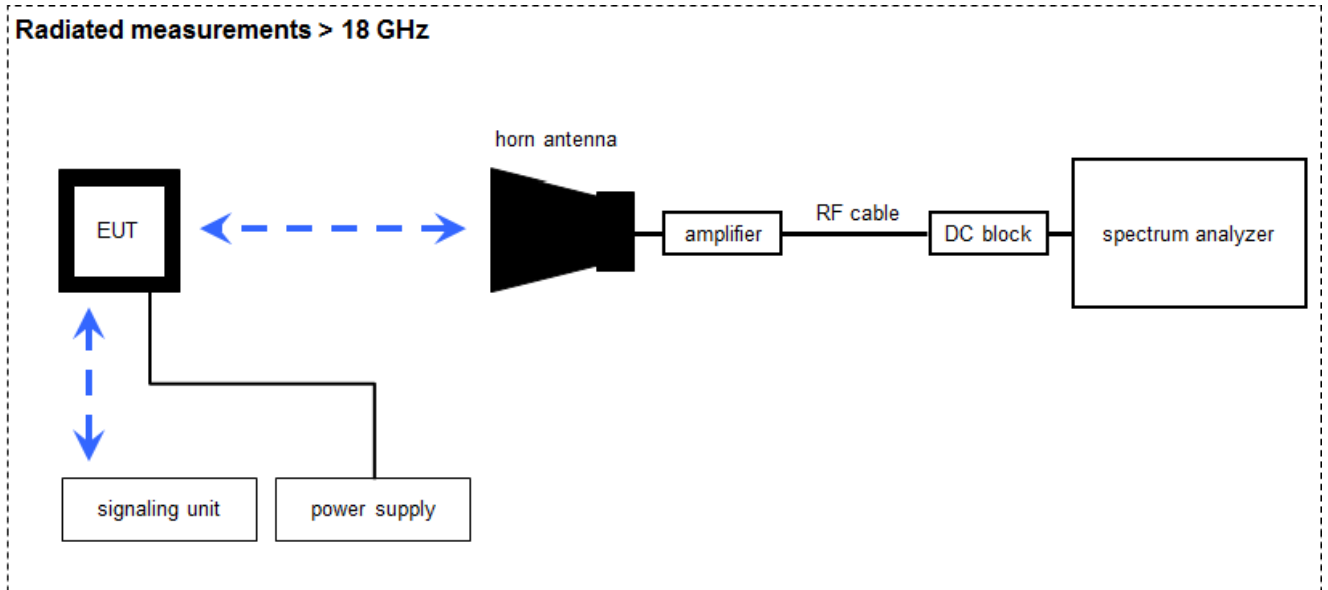
$$FS = UR + CA + AF$$

(FS-field strength; UR-voltage at the receiver; CA-loss of the signal path; AF-antenna factor)

Equipment table:

No.	Setup	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A, C	Double-Ridged Waveguide Horn Antenna 1-18.0GHz	3115	EMCO	8812-3088	300001032	vIKI!	02.08.2021	31.08.2023
2	B	Active Loop Antenna 9 kHz to 30 MHz	6502	EMCO	2210	300001015	vIKI!	01.07.2021	31.07.2023
3	A	Highpass Filter	WHK1.1/15G-10SS	Wainwright	37	400000148	ne	-/-	-/-
4	A	Highpass Filter	WHKX7.0/18G-8SS	Wainwright	18	300003789	ne	-/-	-/-
5	A, C	Broadband Amplifier 0.5-18 GHz	CBLU5184540	CERNEX	22051	300004483	ev	-/-	-/-
6	A, B, C	4U RF Switch Platform	L4491A	Agilent Technologies	MY50000032	300004510	ne	-/-	-/-
7	A, B, C	Computer	Intel Core i3 3220/3,3 GHz, Prozessor		2V2403033A54 21	300004591	ne	-/-	-/-
8	A	Highpass Filter	WHKX2.6/18G-10SS	Wainwright	12	300004651	ne	-/-	-/-
9	A, B, C	NEXIO EMV-Software	BAT EMC V2022.0.22.0	Nexio		300004682	ne	-/-	-/-
10	A, B, C	Anechoic chamber		TDK		300003726	ne	-/-	-/-
11	A, B, C	EMI Test Receiver 9kHz-26,5GHz	ESR26	Rohde & Schwarz	101376	300005063	k	13.12.2022	31.12.2023
12	A	Band Reject Filter	WRCJV12-5120-5150-5350-5380-40SS	Wainwright	5	300005168	ev	-/-	-/-
13	A	RF-Amplifier	AMF-6F06001800-30-10P-R	NARDA-MITEQ Inc	2011571	300005240	ev	-/-	-/-

7.3 Radiated measurements > 18 GHz



Measurement distance: horn antenna 50 cm

$$OP = AV + D - G + CA$$

(OP-radiated output power; AV-analyzer value; D-free field attenuation of measurement distance;
G-antenna gain+amplifier gain; CA-loss signal path)

Example calculation:

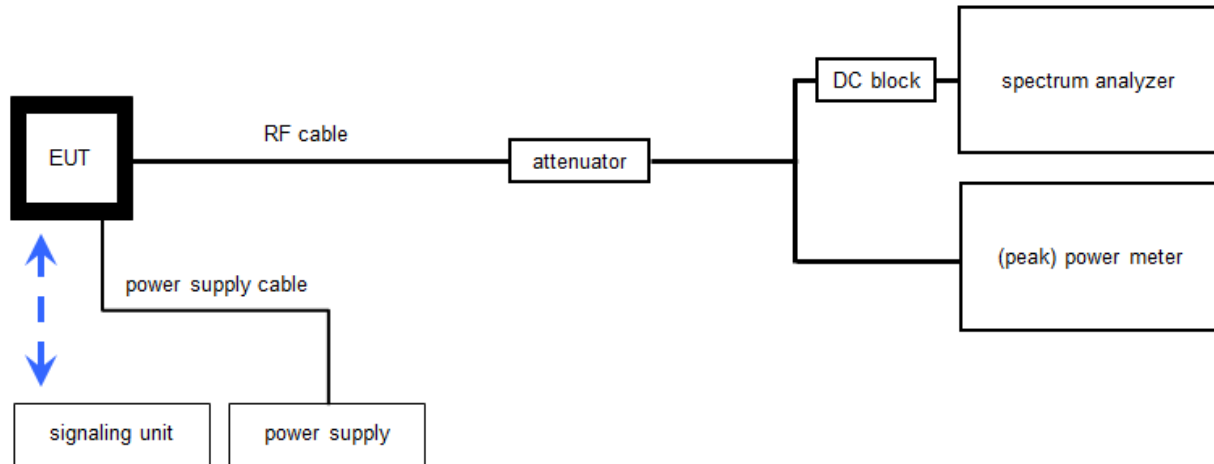
$$OP \text{ [dBm]} = -59.0 \text{ [dBm]} + 44.0 \text{ [dB]} - 20.0 \text{ [dBi]} + 5.0 \text{ [dB]} = -30 \text{ [dBm]} \text{ (1 } \mu\text{W)}$$

Equipment table:

No.	Setup	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Microwave System Amplifier, 0.5-26.5 GHz	83017A	HP	00419	300002268	ev	-/-	-/-
2	A	Std. Gain Horn Antenna 18.0-26.5 GHz	638	Narda	01096	300000486	vIKI!	17.01.2022	31.01.2024
3	B	Std. Gain Horn Antenna 26.5-40.0 GHz	V637	Narda	82-16	300000510	vIKI!	17.01.2022	31.01.2024
4	B	Broadband Low Noise Amplifier 18-50 GHz	CBL18503070-XX	CERNEX	19338	300004273	ev	-/-	-/-
5	A	Signal analyzer	FSV40	Rohde&Schwarz	101353	300004819	k	08.12.2022	31.12.2023
6	A	RF-Cable	ST18/SMAM/SMAM/48	Huber & Suhner	Batch no. 600918	400001182	ev	-/-	-/-
7	B	Signal- and Spectrum Analyzer 2 Hz - 50 GHz	FSW50	Rohde&Schwarz	101560	300006179	k	04.04.2023	30.04.2024

7.4 Conducted measurements

Conducted measurements normal conditions



WLAN tester version: 1.1.13; LabView2015

OP = AV + CA

(OP-output power; AV-analyzer value; CA-loss signal path)

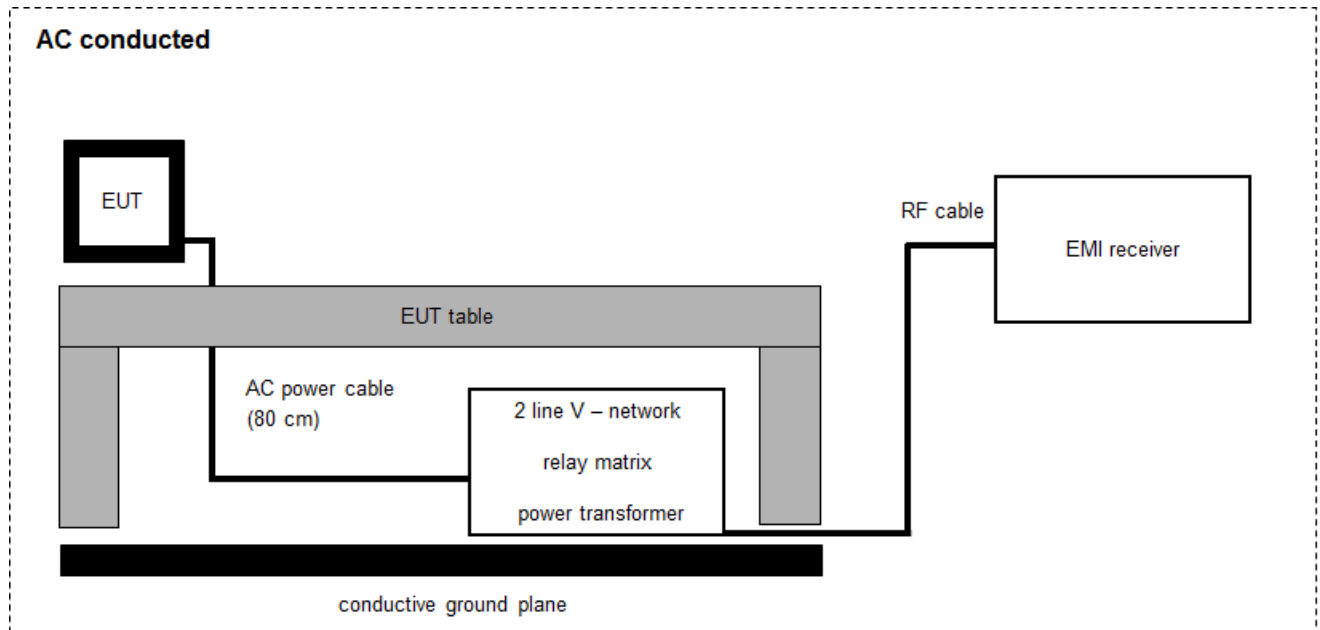
Example calculation:

OP [dBm] = 6.0 [dBm] + 11.7 [dB] = 17.7 [dBm] (58.88 mW)

Equipment table:

No.	Setup	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Signal analyzer	FSV40	Rohde&Schwarz	101042	300004517	k	12.12.2022	31.12.2023
2	A	PC Tester R005	Intel Core i3 3220/3,3 GHz, Prozessor		2V2403033A4523	300004589	ne	-/-	-/-
3	A	Teststand	Teststand Custom Sequence Editor	National Instruments GmbH		300004590	ne	-/-	-/-
4	A	RF-Cable	ST18/SMAm/SMAm /60	Huber & Suhner	Batch no. 606844	400001181	ev	-/-	-/-
5	A	DC-Blocker 0.1-40 GHz	8141A	Inmet		400001185	ev	-/-	-/-
6	A	Coax Attenuator 10 dB 2W 0-40 GHz	MCL BW-K10-2W44+	Mini Circuits		400001186	ev	-/-	-/-
7	A	DC-Blocker	WA7046	Weinschel Associates		400001310	ev	-/-	-/-
8	A	Tester Software RadioStar (C.BER2 for BT Conformance)	Version 1.0.0.X	CTC advanced GmbH	0001	400001380	ne	-/-	-/-

7.5 AC conducted



$$FS = UR + CF + VC$$

(FS-field strength; UR-voltage at the receiver; CR-loss of the cable and filter; VC-correction factor of the ISN)

Example calculation:

$$FS \text{ [dB}\mu\text{V/m]} = 37.62 \text{ [dB}\mu\text{V/m]} + 9.90 \text{ [dB]} + 0.23 \text{ [dB]} = 47.75 \text{ [dB}\mu\text{V/m]} \text{ (244.06 } \mu\text{V/m)}$$

Equipment table:

No.	Setup	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Two-line V-Network (LISN) 9 kHz to 30 MHz	ESH3-Z5	Rohde & Schwarz	892475/017	300002209	vIKII	14.12.2021	31.12.2023
2	A	RF-Filter-section	85420E	HP	3427A00162	300002214	NK!	-/-	-/-
3	A	Analyzer-Reference-System (Harmonics and Flicker)	ARS 16/1	SPS	A3509 07/0 0205	300003314	vIKII	29.12.2021	31.12.2023
4	A	Hochpass 150 kHz	EZ-25	R&S	100010	300003798	ev	-/-	-/-
5	A	PC	TecLine	F+W		300003532	ne	-/-	-/-
6	A	EMI Test Receiver 3.6 GHz	ESR3	Rohde & Schwarz	102981	300006318	k	09.12.2022	31.12.2023

8 Sequence of testing

8.1 Sequence of testing radiated spurious 9 kHz to 30 MHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, it is placed on a table with 0.8 m height.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement*

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna height is 1 m.
- At each turntable position the analyzer sweeps with positive-peak detector to find the maximum of all emissions.

Final measurement

- Identified emissions during the pre-measurement are maximized by the software by rotating the turntable from 0° to 360°.
- Loop antenna is rotated about its vertical axis for maximum response at each azimuth about the EUT. (For certain applications, the loop antenna plane may also need to be positioned horizontally at the specified distance from the EUT)
- The final measurement is done in the position (turntable and elevation) causing the highest emissions with quasi-peak (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, correction factor, margin to the limit and limit will be recorded. A plot with the graph of the premeasurement and the limit is stored.

*Note: The sequence will be repeated three times with different EUT orientations.

8.2 Sequence of testing radiated spurious 30 MHz to 1 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a table with 0.8 m height is used, which is placed on the ground plane.
- If the EUT is a floor standing device, it is placed on the ground plane with insulation between both.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 10 m or 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height changes from 1 m to 3 m.
- At each turntable position, antenna polarization and height the analyzer sweeps three times in peak to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximize the peaks by changing turntable position $\pm 45^\circ$ and antenna height between 1 and 4 m.
- The final measurement is done with quasi-peak detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, antenna height, antenna polarization, turntable angle, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

8.3 Sequence of testing radiated spurious 1 GHz to 18 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height is 1.5 m.
- At each turntable position and antenna polarization the analyzer sweeps with positive peak detector to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximizes the peaks by rotating the turntable from 0° to 360°. This measurement is repeated for different EUT-table positions (0° to 150° in 30°-steps) and for both antenna polarizations.
- The final measurement is done in the position (turntable, EUT-table and antenna polarization) causing the highest emissions with Peak and RMS detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, EUT-table position, antenna polarization, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

8.4 Sequence of testing radiated spurious above 18 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet.
- The measurement distance is as appropriate (e.g. 0.5 m).
- The EUT is set into operation.

Premeasurement

- The test antenna is handheld and moved carefully over the EUT to cover the EUT's whole sphere and different polarizations of the antenna.

Final measurement

- The final measurement is performed at the position and antenna orientation causing the highest emissions with Peak and RMS detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement and the limit is stored.

9 Measurement uncertainty

Measurement uncertainty		
Test case	Uncertainty	
Antenna gain	± 3 dB	
Power spectral density	± 1.56 dB	
DTS bandwidth	± 100 kHz (depends on the used RBW)	
Occupied bandwidth	± 100 kHz (depends on the used RBW)	
Maximum output power conducted	± 1.56 dB	
Detailed spurious emissions @ the band edge - conducted	± 1.56 dB	
Band edge compliance radiated	± 3 dB	
Spurious emissions conducted	> 3.6 GHz	± 1.56 dB
	> 7 GHz	± 1.56 dB
	> 18 GHz	± 2.31 dB
	≥ 40 GHz	± 2.97 dB
Spurious emissions radiated below 30 MHz	± 3 dB	
Spurious emissions radiated 30 MHz to 1 GHz	± 3 dB	
Spurious emissions radiated 1 GHz to 12.75 GHz	± 3.7 dB	
Spurious emissions radiated above 12.75 GHz	± 4.5 dB	
Spurious emissions conducted below 30 MHz (AC conducted)	± 2.6 dB	

10 Summary of measurement results

☒	No deviations from the technical specifications were ascertained
☐	There were deviations from the technical specifications ascertained
☐	This test report is only a partial test report. The content and verdict of the performed test cases are listed below.

TC Identifier	Description	Verdict	Date	Remark
RF-Testing	CFR Title 47 Part 15 RSS 247, Issue 2	See table	2023-05-17	-/-

Test specification clause	Test case	C	NC	NA	NP	Remark
-/-	Output power verification (cond.)	-/-				Declared
-/-	Antenna gain	-/-				Declared
U-NII Part 15	Duty cycle	-/-				-/-
§15.407(a) RSS - 247 (6.2.x.1)	Maximum output power (conducted & radiated)	☒	☐	☐	☐	-/-
§15.407(a) RSS - 247 (6.2.x.1)	Power spectral density	☒	☐	☐	☐	-/-
RSS - 247 (6.2.4.1)	Spectrum bandwidth 6dB bandwidth	☒	☐	☐	☐	-/-
§15.407(a) RSS - 247 (6.2.x.2)	Spectrum bandwidth 26dB bandwidth	☒	☐	☐	☐	-/-
RSS Gen clause 6.6	Spectrum bandwidth 99% bandwidth	-/-				-/-
§15.205 RSS - 247 (6.2.x.2)	Band edge compliance radiated	☒	☐	☐	☐	-/-
§15.407(b) RSS - 247 (6.2.x.2)	TX spurious emissions radiated	☒	☐	☐	☐	-/-
§15.209(a) RSS-Gen	Spurious emissions radiated < 30 MHz	☒	☐	☐	☐	-/-
§15.107(a) §15.207	Spurious emissions conducted emissions< 30 MHz	☒	☐	☐	☐	-/-
§15.407 RSS - 247 (6.3)	DFS	☐	☐	☒	☐	-/-

Notes:

C:	Compliant	NC:	Not compliant	NA:	Not applicable	NP:	Not performed
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11 Additional comments

Reference documents: FLIR-E1330 – Antenna Characterization (3-3-TR587 996-05)
Customer Questionnaire

Special test descriptions: None

Configuration descriptions: Settings used for measurements:

Test mode:	Data rate:	Power setting
a-mode	6 Mbit/s	10
nHT20-mode	MCS0	10

EUT selection:

☐ Only one device available

☒ Devices selected by the customer

☐ Devices selected by the laboratory (Randomly)

Provided channels:

Channels with 20 MHz channel bandwidth:

U-NII-1 & U-NII-2A (5150 MHz to 5250 MHz & 5250 MHz to 5350 MHz) channel number & center frequency								
channel	36	40	44	48	52	56	60	64
f _c / MHz	5180	5200	5220	5240	5260	5280	5300	5320

Note: The channels used for the tests were marked in bold in the list.

Test mode:

- ☐ No test mode available.
lperf is used to transmit data to a companion device
- ☒ Special software is used.
EUT is transmitting pseudo random data by itself

Antennas and transmit operating modes:

- ☒ Operating mode 1 (single antenna)
- Equipment with 1 antenna,
 - Equipment with 2 diversity antennas operating in switched diversity mode by which at any moment in time only 1 antenna is used,
 - Smart antenna system with 2 or more transmit/receive chains, but operating in a mode where only 1 transmit/receive chain is used)
- ☐ Operating mode 2 (multiple antennas, no beamforming)
- Equipment operating in this mode contains a smart antenna system using two or more transmit/receive chains simultaneously but without beamforming.
- ☐ Operating mode 3 (multiple antennas, with beamforming)
- Equipment operating in this mode contains a smart antenna system using two or more transmit/receive chains simultaneously with beamforming.
In addition to the antenna assembly gain (G), the beamforming gain (Y) may have to be taken into account when performing the measurements.

12 Measurement results

12.1 Identify worst case data rate

Results:

OFDM – mode	Modulation scheme / bandwidth	
	U-NII-1	
	lowest channel	highest channel
a – mode	6 Mbit/s	6 Mbit/s
nHT20 – mode	MCS0	MCS0

* Worst case data rate or modulation scheme declared by the manufacturer

12.2 Antenna gain

As declared by the customer: 7.7 dBi

12.3 Duty cycle

Results:

Duty cycle: >98% for all modes and channels

12.4 Maximum output power

12.4.1 Maximum output power according to FCC requirements

Description:

Measurement of the maximum output power conducted

Measurement:

Measurement parameter	
According to: KDB789033 D02, E.2.e.	
External result file(s)	1-5618_22-01-11_Annex_MR1.pdf 1-5618_22-01-11_Annex_MR2.pdf FCC Part 15.407 Max Output Power and PSD
Used test setup:	See chapter 7.4 – A
Measurement uncertainty:	See chapter 9

Limits:

Radiated output power	Conducted output power for mobile equipment
Conducted power + 6 dBi antenna gain	250mW 5.150-5.250 GHz The lesser one of 250mW or 11 dBm + 10 log Bandwidth 5.250-5.350 GHz 250mW or 11 dBm + 10 log Bandwidth 5.470-5.725 GHz (where Bandwidth is the 26dB Bandwidth [MHz]) 1W 5.725-5.85 GHz

Results:

a	Maximum output power conducted [dBm]		
	U-NII-1 (5150 MHz to 5250 MHz)		
	Lowest channel	Middle channel	Highest channel
	8.32	8.48	8.45

Results:

nHT20	Maximum output power conducted [dBm]		
	U-NII-1 (5150 MHz to 5250 MHz)		
	Lowest channel	Middle channel	Highest channel
	7.99	8.27	8.88

12.4.2 Maximum output power according to ISED requirements

Description:

Measurement of the maximum output power conducted + radiated

Measurement:

Measurement parameter	
External result file(s)	1-5618_22-01-11_Annex_MR1.pdf 1-5618_22-01-11_Annex_MR2.pdf ISED Max Output Power and PSD
Used test setup:	See chapter 7.4 – A
Measurement uncertainty:	See chapter 9

Limits:

Radiated output power	Conducted output power for mobile equipment
The lesser one of 200 mW or 10 dBm + 10 log Bandwidth 5.150-5.250 GHz 1 W or 17 dBm + 10 log Bandwidth 5.250-5.350 GHz 1 W or 17 dBm + 10 log Bandwidth 5.470-5.725 GHz (where Bandwidth is the 99% Bandwidth [MHz]) Conducted power + 6dBi antenna gain 5.725-5.825 GHz	The lesser one of 250mW or 11 dBm + 10 log Bandwidth 5.250-5.350 GHz 250mW or 11 dBm + 10 log Bandwidth 5.470-5.725 GHz (where Bandwidth is the 99% Bandwidth [MHz]) 1W 5.725-5.825 GHz

Results:

a	Maximum output power [dBm]		
	U-NII-1 (5150 MHz to 5250 MHz)		
	Lowest channel	Middle channel	Highest channel
	Conducted		
	8.26	8.38	8.37
	Radiated (calculated – see chapter antenna gain)		
	15.96	16.08	16.07

Results:

nHT20	Maximum output power [dBm]		
	U-NII-1 (5150 MHz to 5250 MHz)		
	Lowest channel	Middle channel	Highest channel
	Conducted		
	7.98	8.01	9.17
	Radiated (calculated – see chapter antenna gain)		
	15.68	15.71	16.87

12.5 Power spectral density

12.5.1 Power spectral density according to FCC requirements

Description:

Measurement of the power spectral density of a digital modulated system. The measurement is repeated at the lowest, middle and highest channel.

Measurement:

Measurement parameter	
According to: KDB789033 D02, F.	
External result file(s)	1-5618_22-01-11_Annex_MR1.pdf 1-5618_22-01-11_Annex_MR2.pdf FCC Part 15.407 Max Output Power and PSD
Used test setup:	See chapter 7.4 – A
Measurement uncertainty:	See chapter 9

Limits:

Power Spectral Density
power spectral density conducted ≤ 11 dBm in any 1 MHz band (band 5150 – 5250 MHz)
power spectral density conducted ≤ 11 dBm in any 1 MHz band (band 5250 – 5350 MHz)
power spectral density conducted ≤ 11 dBm in any 1 MHz band (band 5470 – 5725 MHz)
power spectral density conducted ≤ 30 dBm in any 500 kHz band (band 5725 – 5850 MHz)

Results:

a	Power spectral density (dBm/1MHz or dBm/500kHz)		
	U-NII-1 (5150 MHz to 5250 MHz)		
	Lowest channel	Middle channel	Highest channel
	-2.4	-2.25	-2.29

Results:

nHT20	Power spectral density (dBm/1MHz or dBm/500kHz)		
	U-NII-1 (5150 MHz to 5250 MHz)		
	Lowest channel	Middle channel	Highest channel
	-3.26	-2.61	-1.95

12.5.2 Power spectral density according to ISED requirements

Description:

Measurement of the power spectral density of a digital modulated system. The measurement is repeated at the lowest, middle and highest channel.

Measurement:

Measurement parameter	
External result file(s)	1-5618_22-01-11_Annex_MR1.pdf 1-5618_22-01-11_Annex_MR2.pdf ISED Max Output Power and PSD
Used test setup:	See chapter 7.4 – A
Measurement uncertainty:	See chapter 9

Limits:

Power Spectral Density
power spectral density e.i.r.p. ≤ 10 dBm in any 1 MHz band (band 5150 – 5250 MHz)
power spectral density conducted ≤ 11 dBm in any 1 MHz band (band 5250 – 5350 MHz)
power spectral density conducted ≤ 11 dBm in any 1 MHz band (band 5470 – 5725 MHz)
power spectral density conducted ≤ 30 dBm in any 500 kHz band (band 5725 – 5850 MHz)

Results:

a	Power spectral density (dBm/1MHz or dBm/500kHz)		
	U-NII-1 (5150 MHz to 5250 MHz)		
	Lowest channel	Middle channel	Highest channel
	Conducted		
	-2.38	-2.27	-2.31
	Radiated (calculated – see chapter antenna gain)		
	5.32	5.43	5.39

Results:

nHT20	Power spectral density (dBm/1MHz or dBm/500kHz)		
	U-NII-1 (5150 MHz to 5250 MHz)		
	Lowest channel	Middle channel	Highest channel
	Conducted		
	-3.19	-3.16	-1.93
	Radiated (calculated – see chapter antenna gain)		
	4.51	4.54	5.77

12.6 Spectrum bandwidth / 26 dB bandwidth

Description:

Measurement of the 26 dB bandwidth of the modulated signal.

Measurement:

Measurement parameter	
According to: KDB789033 D02, C.1.	
External result file(s)	1-5618_22-01-11_Annex_MR1.pdf 1-5618_22-01-11_Annex_MR2.pdf FCC Part 15.407 & ISSED Bandwidths
Used test setup:	see chapter 7.4 – A
Measurement uncertainty:	See chapter 9

Limits:

Spectrum Bandwidth – 26 dB Bandwidth
IC: Any unwanted emissions that fall into the band 5250-5350 MHz shall be attenuated below the channel power by at least 26 dB, when measured using a resolution bandwidth between 1 and 5% of the occupied bandwidth (i.e. 99% bandwidth), above 5250 MHz. The 26 dB bandwidth may fall into the 5250-5350 MHz band; however, if the occupied bandwidth also falls within the 5250-5350 MHz band, the transmission is considered as intentional and the devices shall comply with all requirements in the band 5250-5350 MHz including implementing dynamic frequency selection (DFS) and TPC, on the portion of the emission that resides in the 5250-5350 MHz band. FCC: Radar Detection Function of Dynamic Frequency Selection (DFS). U-NII devices operating with any part of its 26 dB emission bandwidth in the 5.25-5.35 GHz and 5.47-5.725 GHz bands shall employ a DFS radar detection mechanism to detect the presence of radar systems and to avoid co-channel operation with radar systems.

Results:

a	26 dB bandwidth (MHz)		
	U-NII-1 (5150 MHz to 5250 MHz)		
	Lowest channel	Middle channel	Highest channel
	20.55	20.4	20.5
	Lowest frequency		Highest frequency
	5171.8		5248.2

Results:

nHT20	26 dB bandwidth (MHz)		
	U-NII-1 (5150 MHz to 5250 MHz)		
	Lowest channel	Middle channel	Highest channel
	20.7	20.65	20.65
	Lowest frequency		Highest frequency
	5169.9		5250.55

12.7 Occupied bandwidth / 99% emission bandwidth

Description:

Measurement of the 99% bandwidth of the modulated signal acc. RSS-GEN.

Measurement:

Measurement parameter	
External result file(s)	1-5618_22-01-11_Annex_MR1.pdf 1-5618_22-01-11_Annex_MR2.pdf FCC Part 15.407 & ISED Bandwidths
Test setup:	See sub clause 7.4 – B
Measurement uncertainty:	See chapter 9

Usage:

-/-	ISED
OBW is necessary for Emission Designator	

Results:

a	99% bandwidth (kHz)		
	U-NII-1 (5150 MHz to 5250 MHz)		
	Lowest channel	Middle channel	Highest channel
	16433.6	16433.6	16433.6

Results:

nHT20	99% bandwidth (kHz)		
	U-NII-1 (5150 MHz to 5250 MHz)		
	Lowest channel	Middle channel	Highest channel
	17482.5	17482.5	17482.5

12.8 Band edge compliance radiated

Description:

Measurement of the radiated band edge compliance. The EUT is turned in the position that results in the maximum level at the band edge. Then a sweep over the corresponding restricted band is performed. The EUT is set to the lowest channel for the lower restricted band and to the highest channel for the upper restricted band. Measurement distance is 3m.

Measurement:

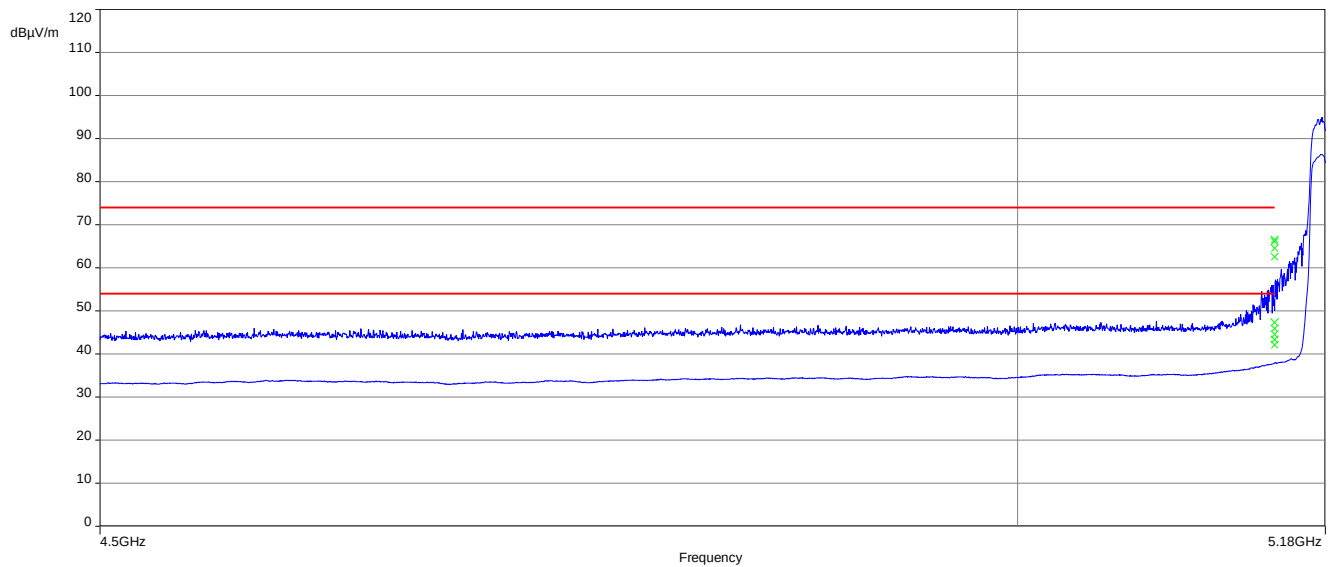
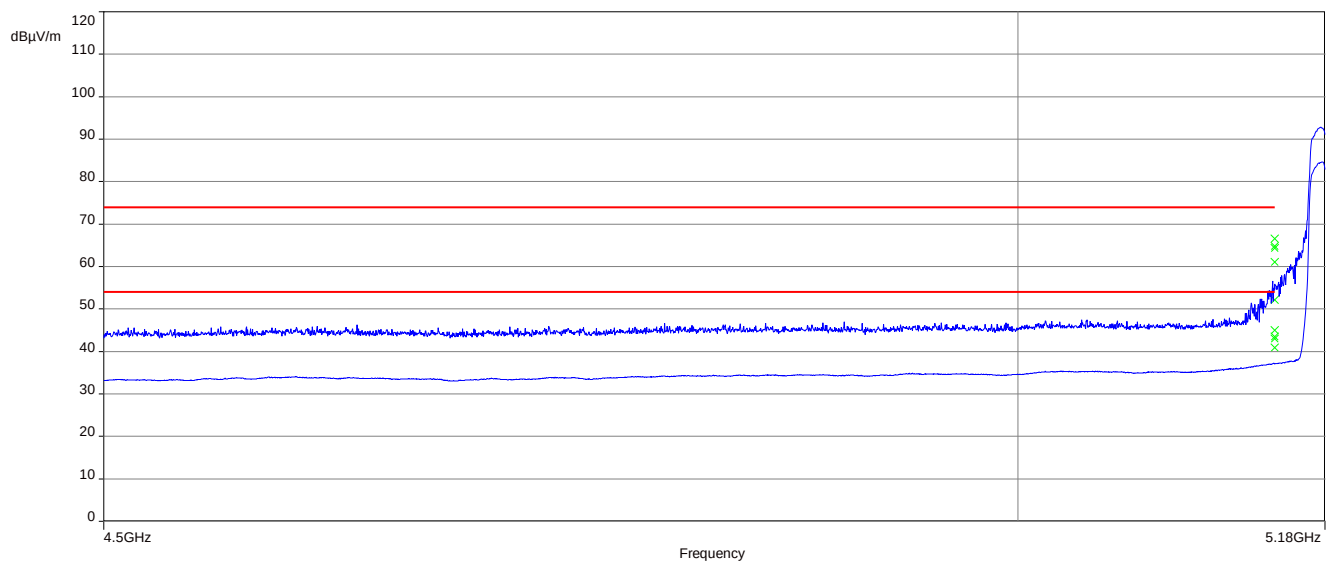
Measurement parameter	
Detector:	Peak / RMS
Sweep time:	Auto
Resolution bandwidth:	1 MHz
Video bandwidth:	$\geq 3 \times \text{RBW}$
Span:	See plots!
Trace mode:	Max Hold
Test setup:	See sub clause 7.2 – C
Measurement uncertainty:	See chapter 9

Limits:

Band Edge Compliance Radiated
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in Section 15.205(a), must also comply with the radiated emission limits specified in Section 15.209(a) (see Section 5.205(c)).
74 dB μ V/m (peak) 54 dB μ V/m (average)

Result:

Scenario	Band Edge Compliance Radiated [dB μ V/m]
band edge	< 74 dB μ V/m (peak) < 54 dB μ V/m (average)

Plots:**Plot 1:** lower band edge; U-NII-1; lowest channel; 20 MHz channel bandwidth a-mode**Plot 2:** lower band edge; U-NII-1; lowest channel; 20 MHz channel bandwidth nHT20-mode

12.9 Spurious emissions radiated below 30 MHz

Description:

Measurement of the radiated spurious emissions in transmit mode below 30 MHz. The limits are re-calculated to a measurement distance of 3 m with 40 dB/decade according CFR Part 2.

Measurement:

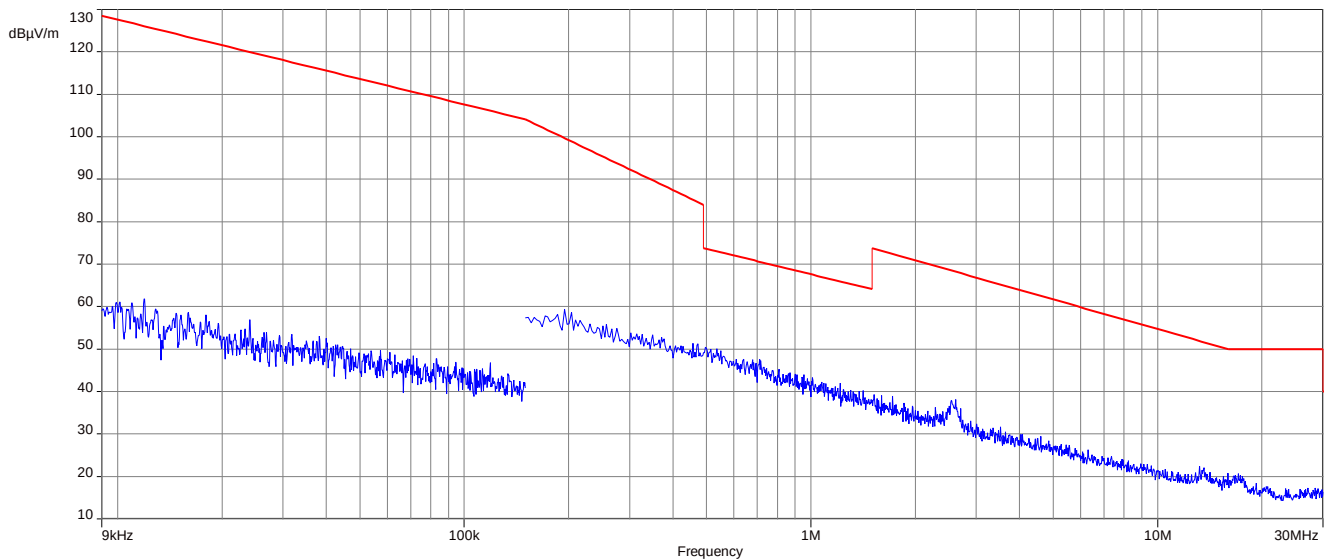
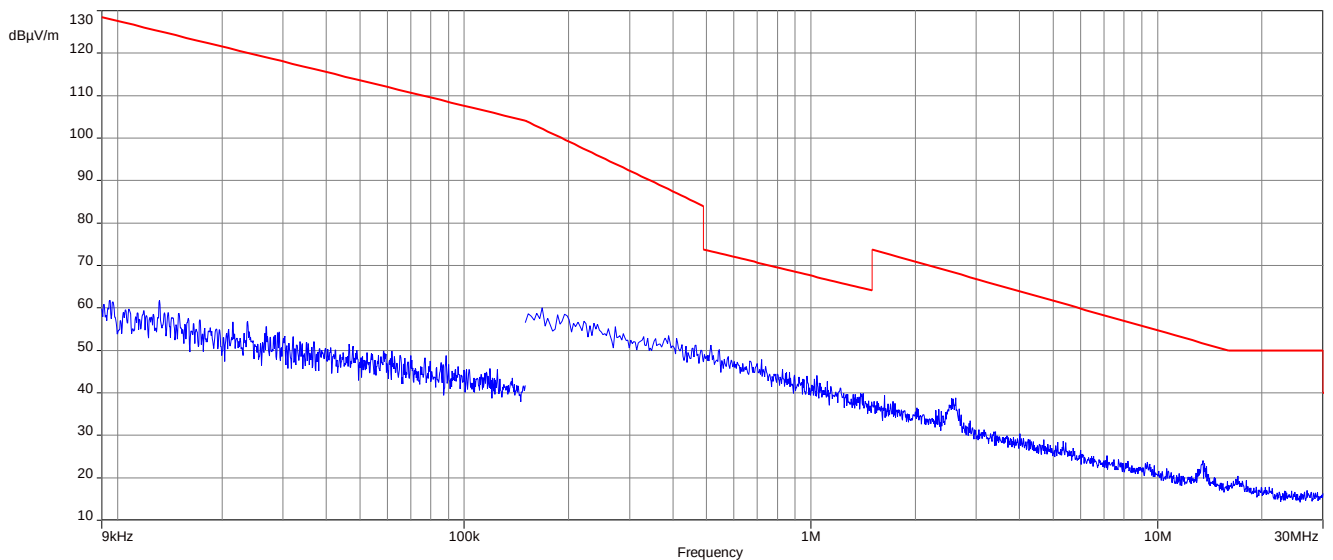
Measurement parameter	
Detector:	Peak / Quasi Peak
Sweep time:	Auto
Video bandwidth:	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Resolution bandwidth:	F < 150 kHz: 1 kHz F > 150 kHz: 100 kHz
Span:	9 kHz to 30 MHz
Trace mode:	Max Hold
Test setup:	See sub clause 7.2 – C
Measurement uncertainty:	See chapter 9

Limits:

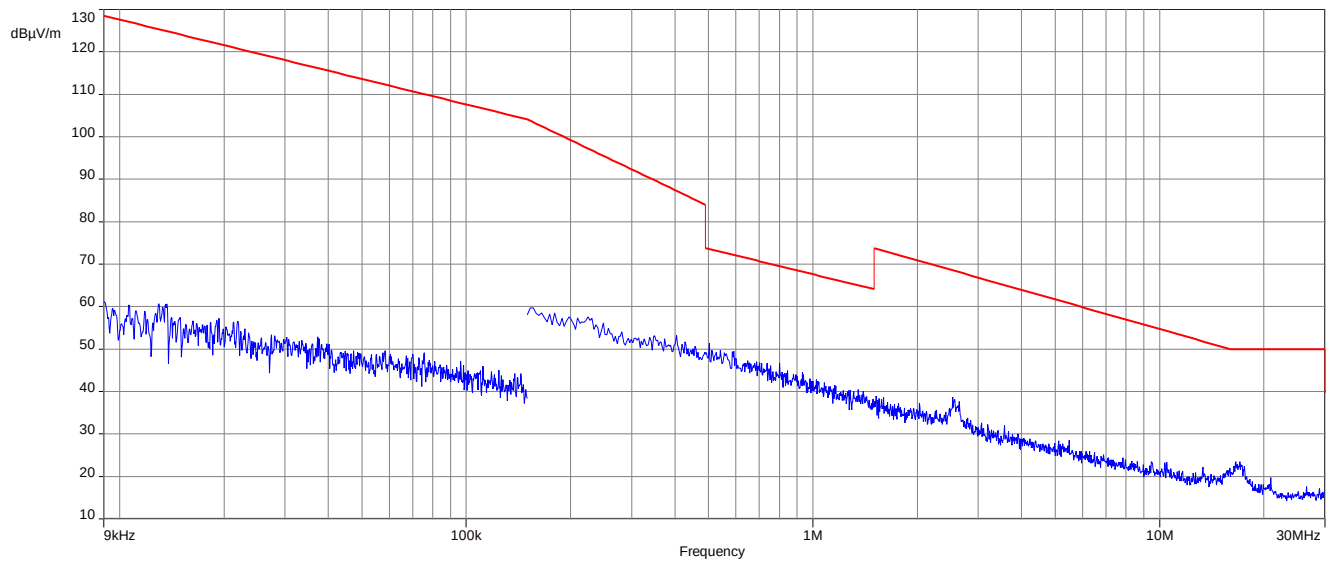
Spurious Emissions Radiated < 30 MHz		
Frequency (MHz)	Field Strength (dB μ V/m)	Measurement distance
0.009 – 0.490	2400/F(kHz)	300
0.490 – 1.705	24000/F(kHz)	30
1.705 – 30.0	30	30

Results:

Spurious Emissions Radiated < 30 MHz [dB μ V/m]		
F [MHz]	Detector	Level [dB μ V/m]
All detected emissions are more than 20 dB below the limit.		

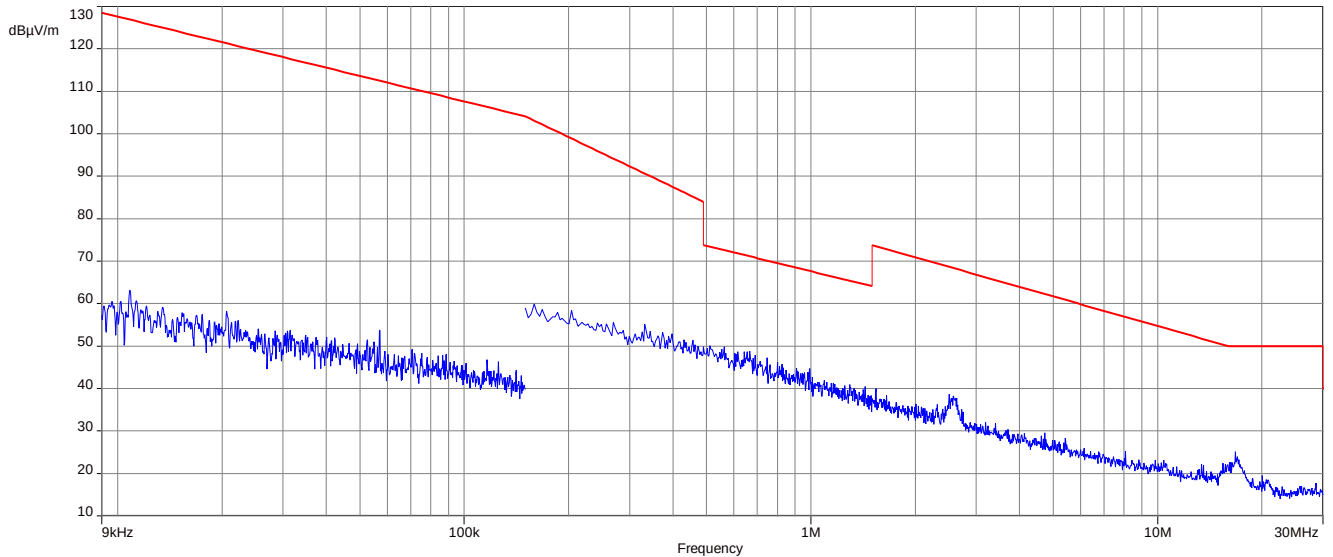
Plots: 20 MHz channel bandwidth a-mode**Plot 1:** 9 kHz to 30 MHz, U-NII-1; lowest channel**Plot 2:** 9 kHz to 30 MHz, U-NII-1; middle channel

Plot 3: 9 kHz to 30 MHz, U-NII-1; highest channel

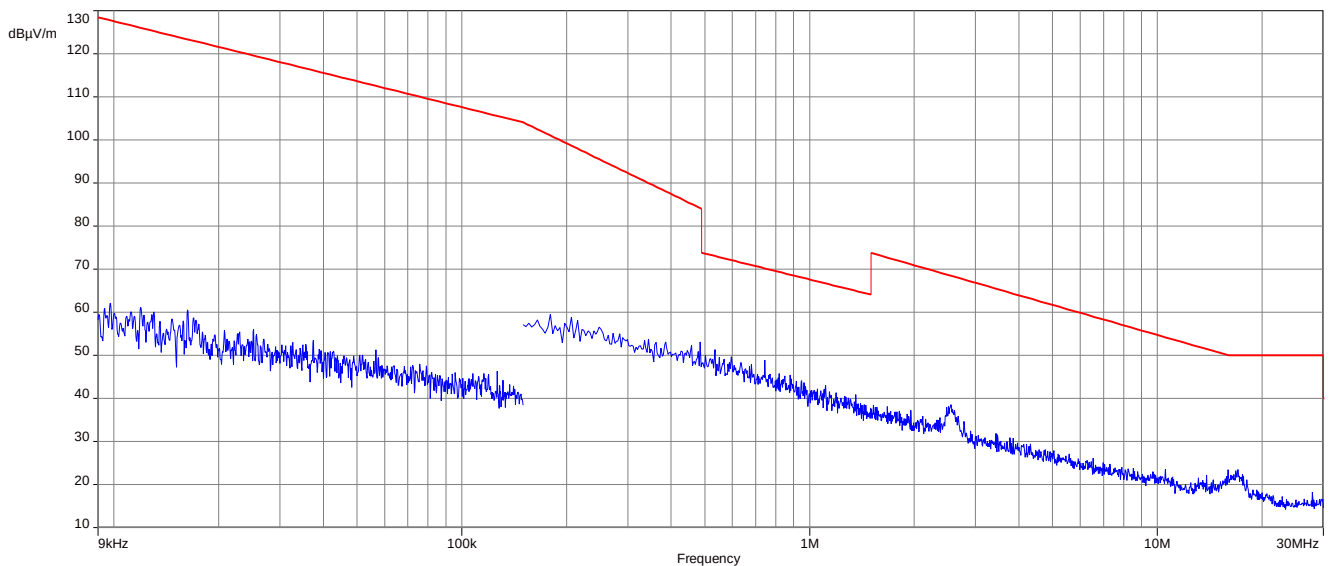


Plots: 20 MHz channel bandwidth nHT20-mode

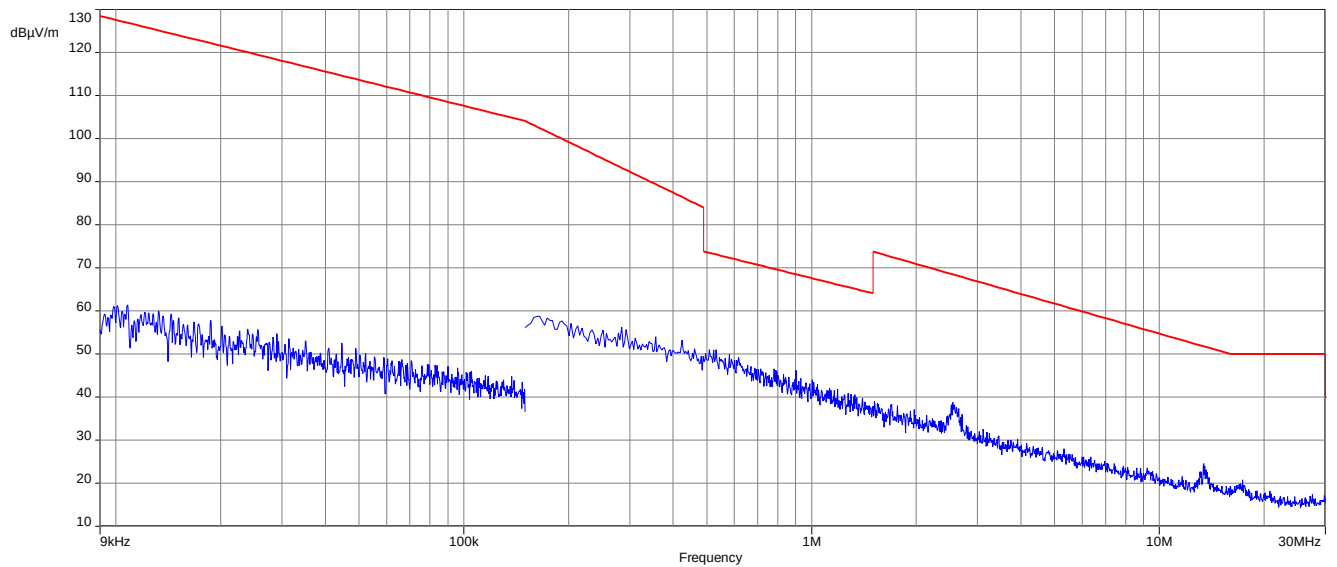
Plot 4: 9 kHz to 30 MHz, U-NII-1; lowest channel



Plot 5: 9 kHz to 30 MHz, U-NII-1; middle channel



Plot 6: 9 kHz to 30 MHz, U-NII-1; highest channel



12.10 Spurious emissions radiated 30 MHz to 1 GHz

Description:

Measurement of the radiated spurious emissions and cabinet radiations below 1 GHz.

Measurement:

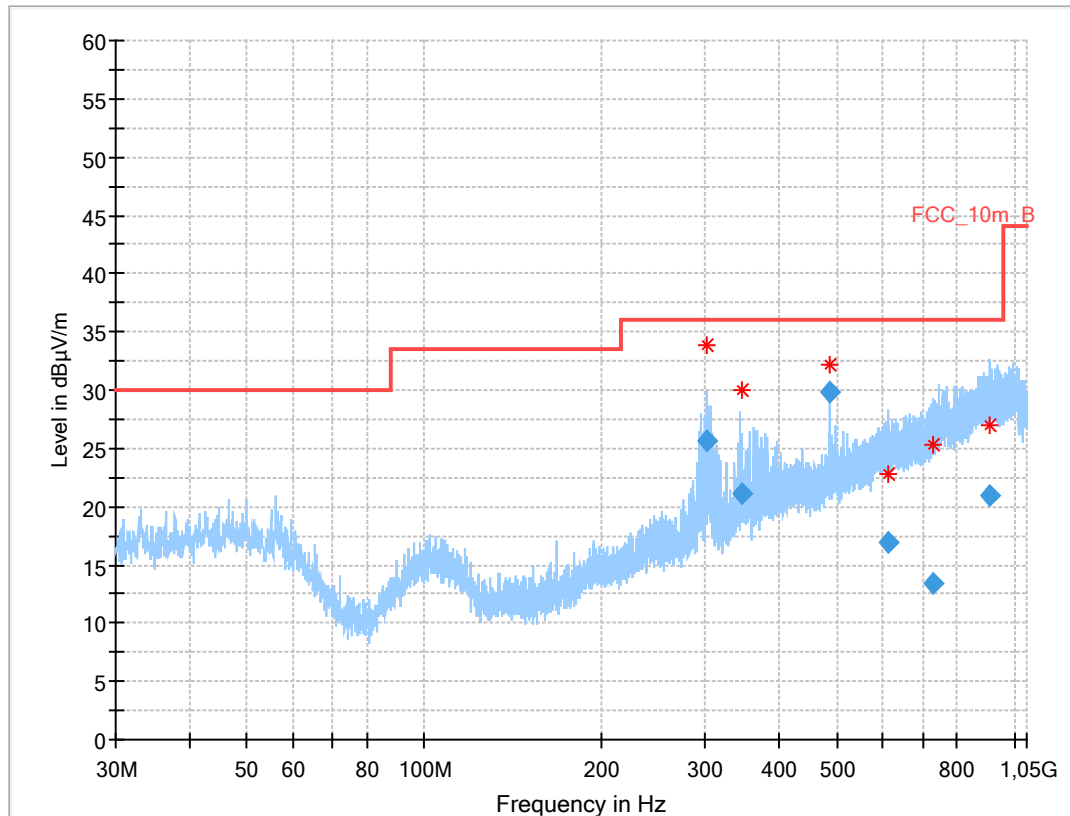
Measurement parameter	
Detector:	Quasi Peak
Sweep time:	Auto
Resolution bandwidth:	120 kHz
Video bandwidth:	500 kHz
Span:	30 MHz to 1 GHz
Test setup:	See sub clause 7.1 – A
Measurement uncertainty:	See chapter 9

Limits:

TX Spurious Emissions Radiated		
§15.209 / RSS-247		
Frequency (MHz)	Field Strength (dB μ V/m)	Measurement distance
30 - 88	30.0	10
88 – 216	33.5	10
216 – 960	36.0	10
Above 960	54.0	3
§15.407		
Outside the restricted bands!	-27 dBm / MHz	

Plots: 20 MHz channel bandwidth a-mode

Plot 1: 30 MHz to 1 GHz; vertical & horizontal polarization; U-NII-1; valid for all channels

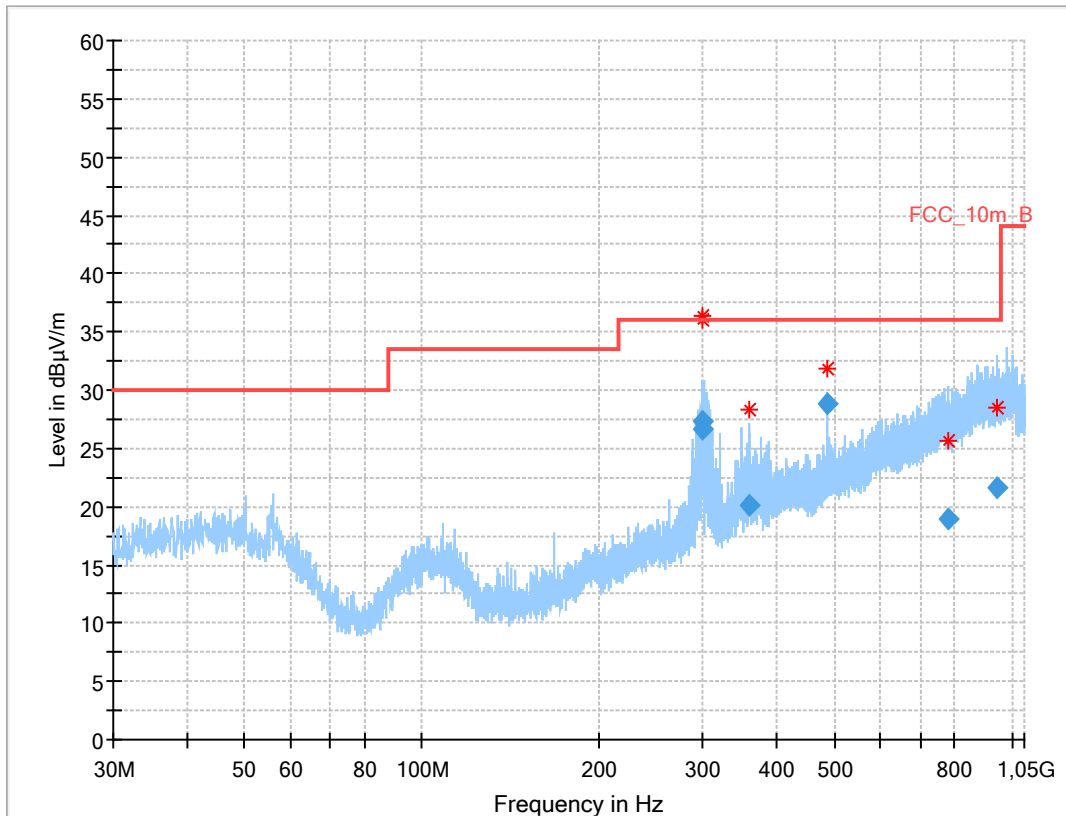


Results:

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
301.199	25.72	36.0	10.3	1000	120.0	277.0	H	14	15
344.283	21.07	36.0	14.9	1000	120.0	265.0	H	191	17
486.351	29.88	36.0	6.1	1000	120.0	129.0	H	174	19
610.118	16.91	36.0	19.1	1000	120.0	185.0	V	180	22
729.646	13.48	36.0	22.5	1000	120.0	200.0	H	133	23
907.659	20.98	36.0	15.0	1000	120.0	181.0	V	0	26

Plots: 20 MHz channel bandwidth nHT20-mode

Plot 2: 30 MHz to 1 GHz; vertical & horizontal polarization; U-NII-1; valid for all channels



Results:

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
298.681	27.38	36.0	8.6	1000	120.0	372.0	H	193	15
299.976	26.59	36.0	9.4	1000	120.0	400.0	H	9	15
359.189	20.14	36.0	15.9	1000	120.0	295.0	H	185	17
486.358	28.80	36.0	7.2	1000	120.0	226.0	H	0	19
782.242	18.88	36.0	17.1	1000	120.0	396.0	H	135	24
940.778	21.69	36.0	14.3	1000	120.0	106.0	H	180	26

12.11 Spurious emissions radiated 1 GHz to 40 GHz

Description:

Measurement of the radiated spurious emissions and cabinet radiations from 1 GHz to 40 GHz.

Measurement:

Measurement parameter	
Detector:	Quasi Peak below 1 GHz (alternative Peak) Peak above 1 GHz / RMS
Sweep time:	Auto
Resolution bandwidth:	1 MHz
Video bandwidth:	3 MHz
Span:	1 GHz to 40 GHz
Trace mode:	Max Hold / Average with 100 counts + 20 log (1 / X) for duty cycle lower than 100 %
Test setup:	See sub clause 7.2 – A See sub clause 7.3 – A+B
Measurement uncertainty:	See chapter 9

Limits:

TX Spurious Emissions Radiated		
§15.209 / RSS-247		
Frequency (MHz)	Field Strength (dBµV/m)	Measurement distance
Above 960	54.0	3
§15.407		
Outside the restricted bands!	-27 dBm / MHz	

Results: 20 MHz channel bandwidth a-mode

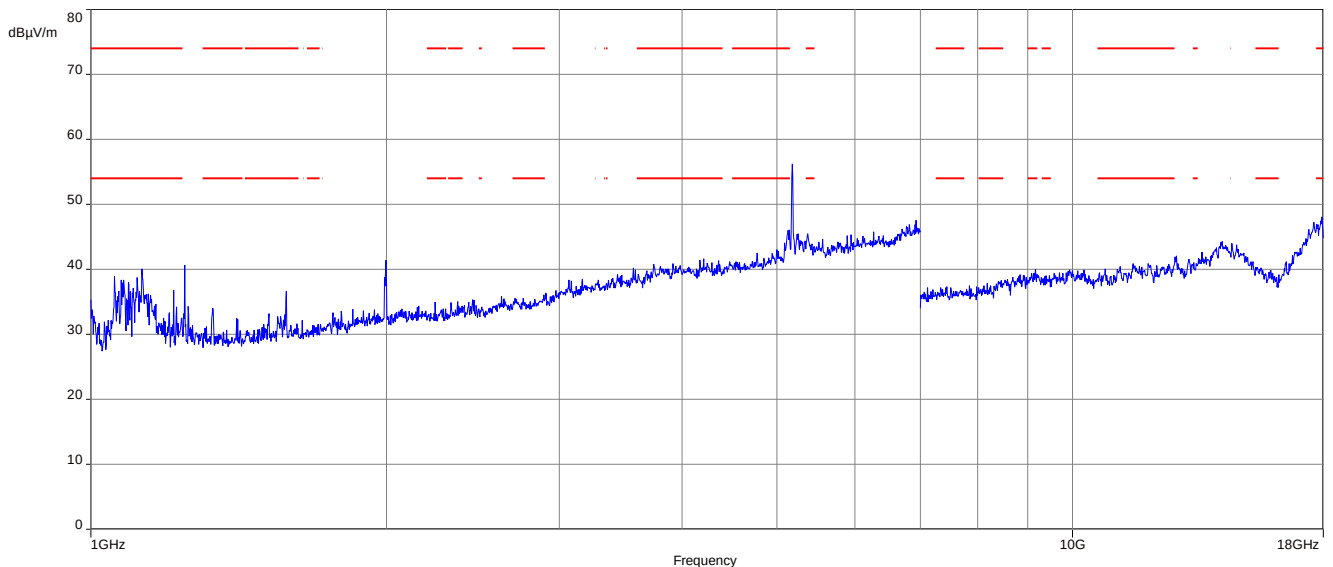
TX Spurious Emissions Radiated [dB μ V/m] / dBm								
U-NII-1 (5150 MHz to 5250 MHz)								
Lowest channel			Middle channel			Highest channel		
F [MHz]	Detector	Level [dB μ V/m]	F [MHz]	Detector	Level [dB μ V/m]	F [MHz]	Detector	Level [dB μ V/m]
All detected emissions are more than 20 dB below the limit.			All detected emissions are more than 20 dB below the limit.			All detected emissions are more than 20 dB below the limit.		

Results: 20 MHz channel bandwidth nHT20-mode

TX Spurious Emissions Radiated [dB μ V/m] / dBm								
U-NII-1 (5150 MHz to 5250 MHz)								
Lowest channel			Middle channel			Highest channel		
F [MHz]	Detector	Level [dB μ V/m]	F [MHz]	Detector	Level [dB μ V/m]	F [MHz]	Detector	Level [dB μ V/m]
All detected emissions are more than 20 dB below the limit.			All detected emissions are more than 20 dB below the limit.			All detected emissions are more than 20 dB below the limit.		

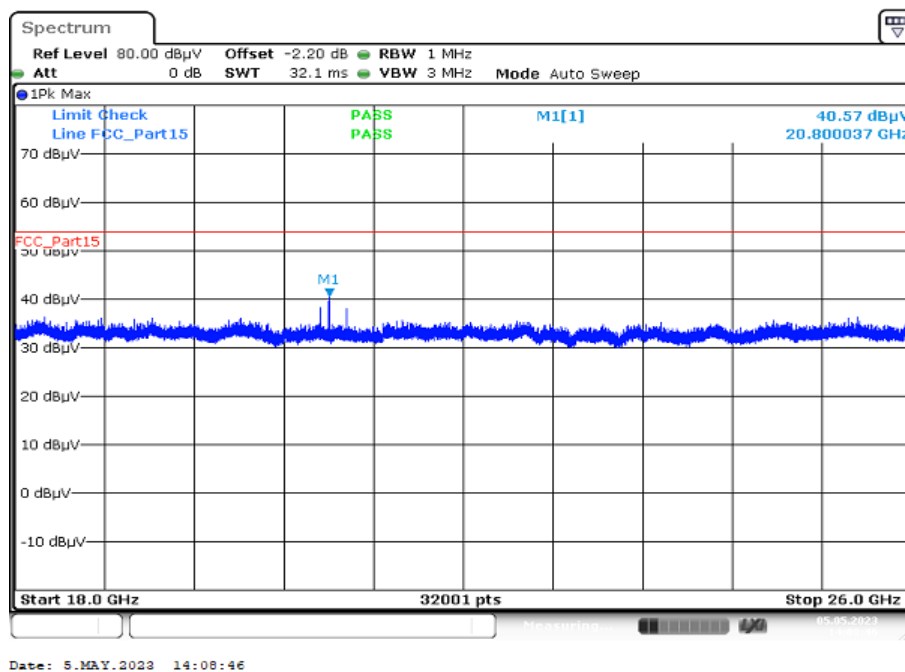
Plots: 20 MHz channel bandwidth a-mode

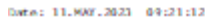
Plot 1: 1 GHz to 18 GHz; vertical & horizontal polarization; U-NII-1; lowest channel



NOTE: The carrier is notched with a band rejection filter.

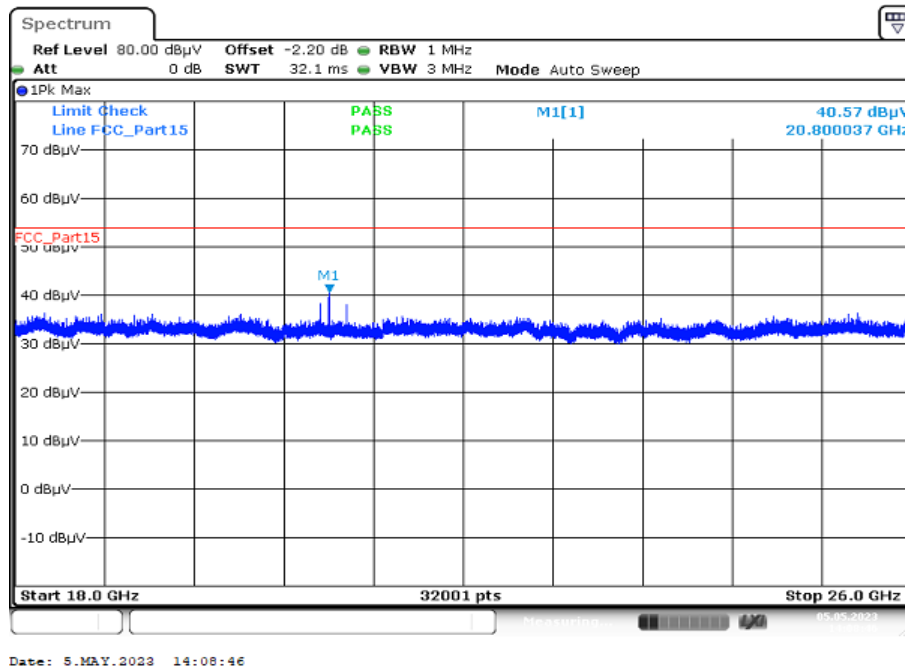
Plot 2: 18 GHz to 26 GHz; vertical & horizontal polarization; U-NII-1; lowest channel



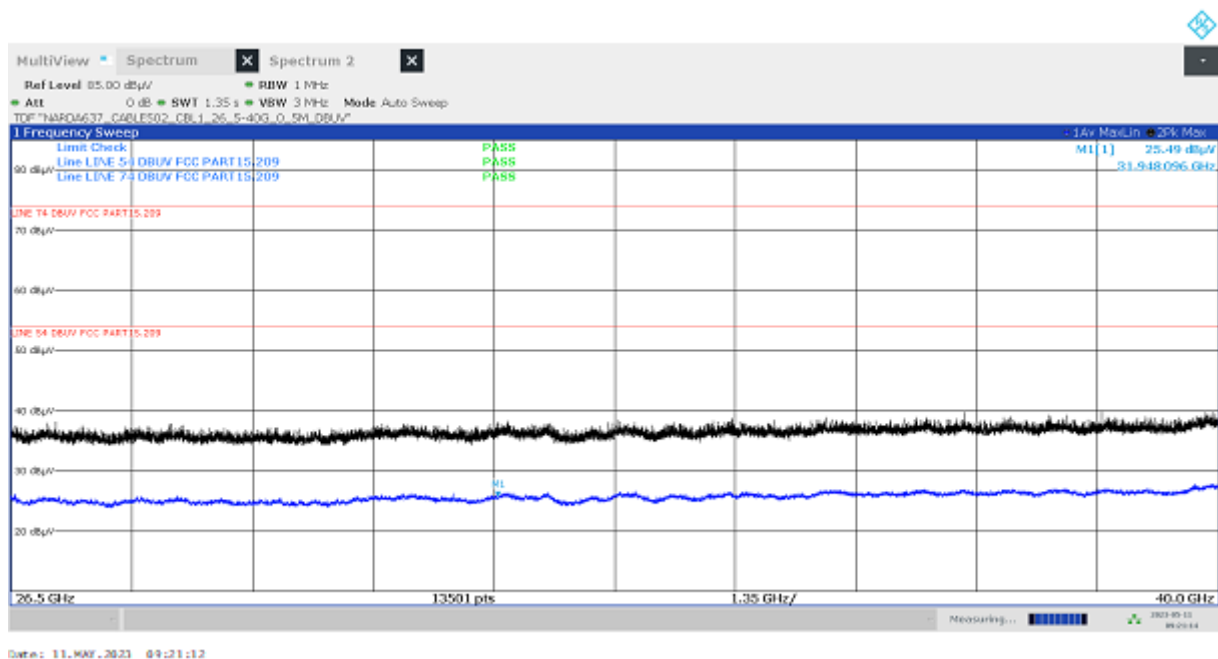
[illegible]

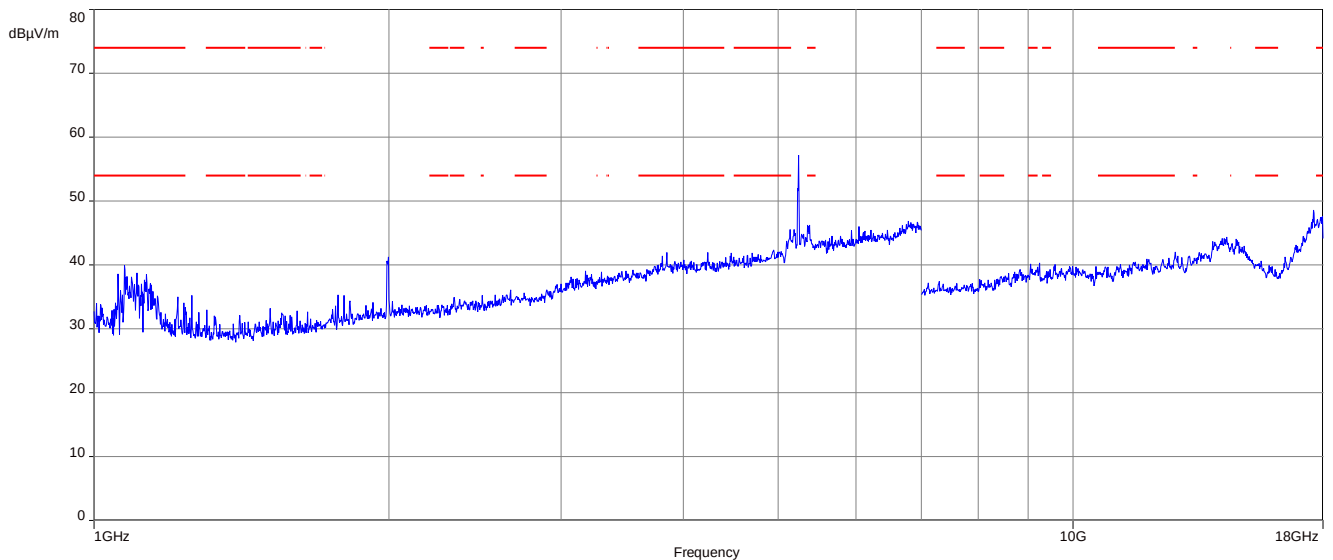
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Plot 5: 18 GHz to 26 GHz; vertical & horizontal polarization; U-NII-1; middle channel

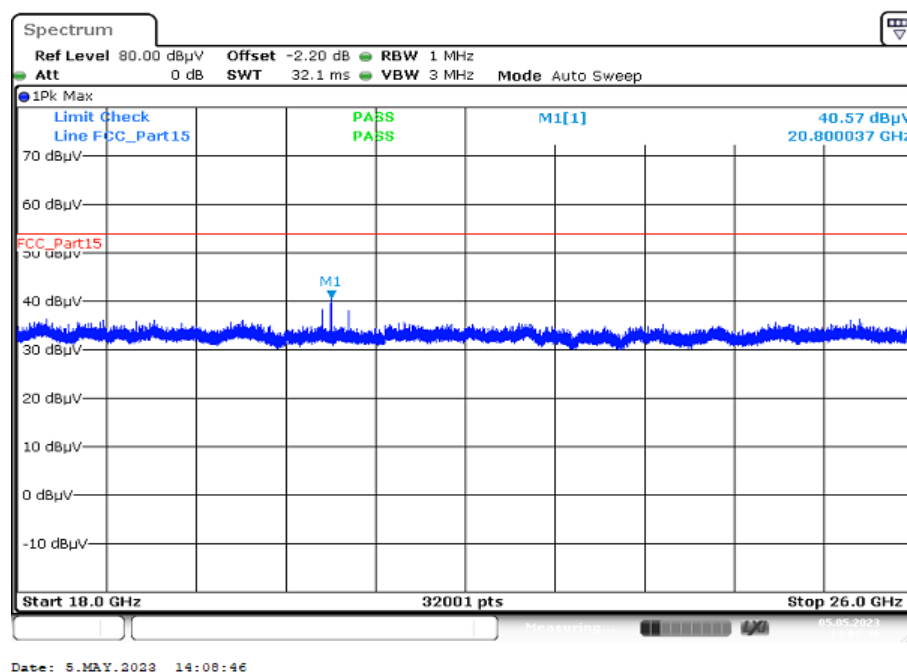


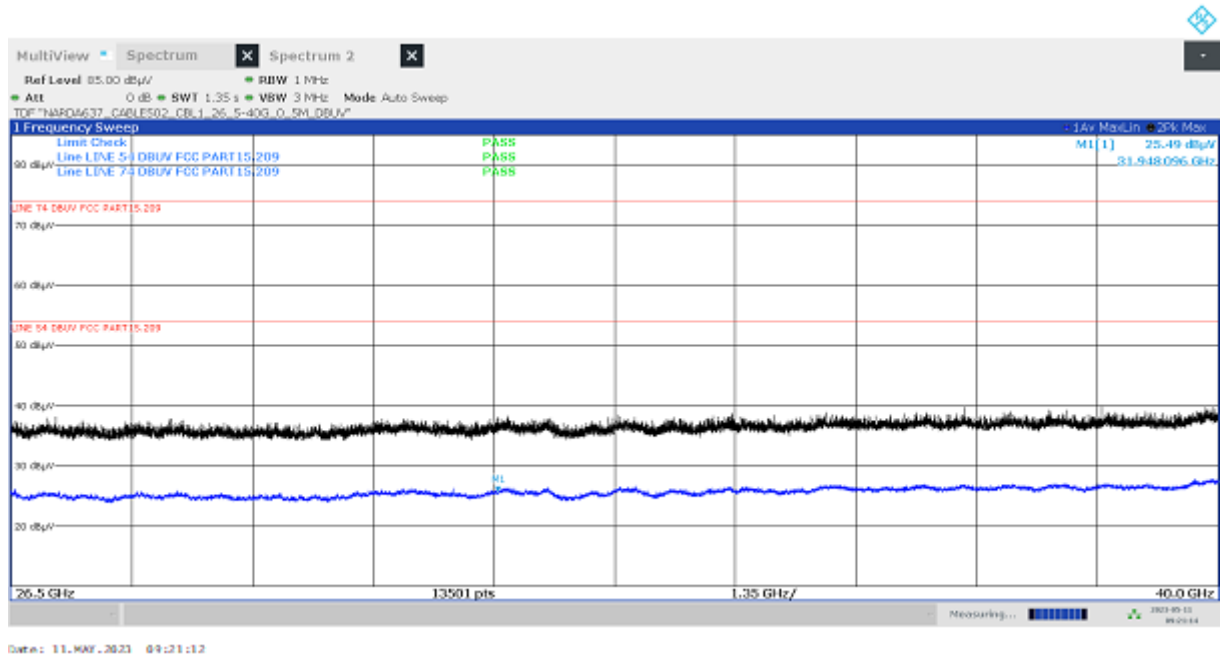
Plot 6: 26 GHz to 40 GHz; vertical & horizontal polarization; U-NII-1; middle channel



Plot 7: 1 GHz to 18 GHz; vertical & horizontal polarization; U-NII-1; highest channel

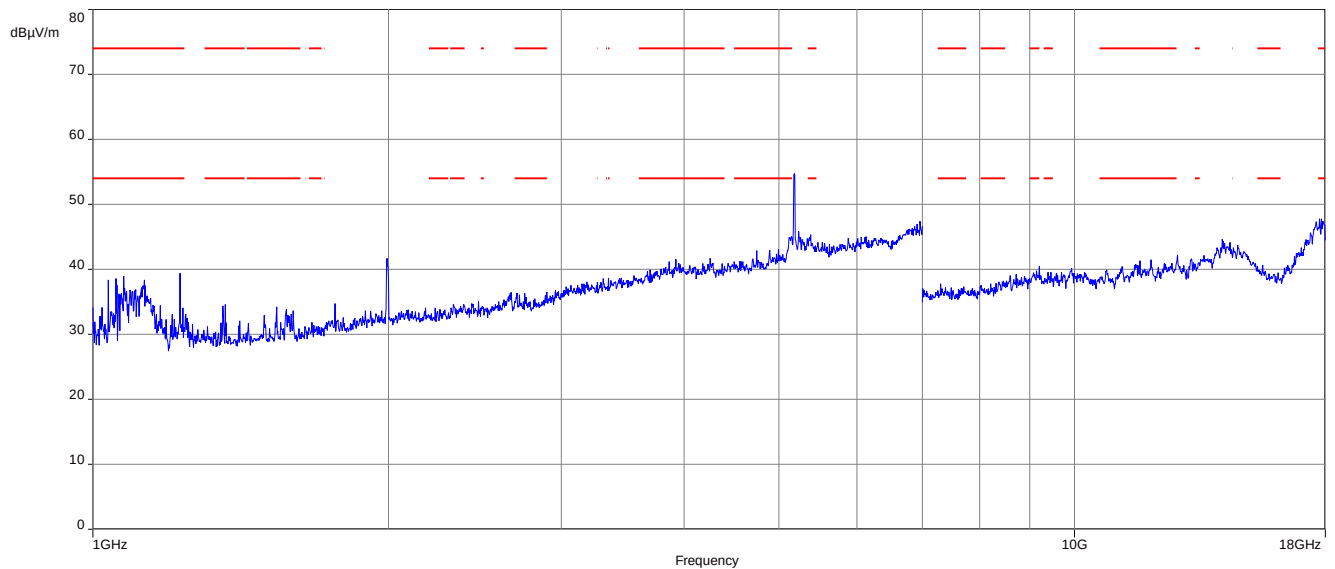
NOTE: The carrier is notched with a band rejection filter.

Plot 8: 18 GHz to 26 GHz; vertical & horizontal polarization; U-NII-1; highest channel

Plot 9: 26 GHz to 40 GHz; vertical & horizontal polarization; U-NII-1; highest channel

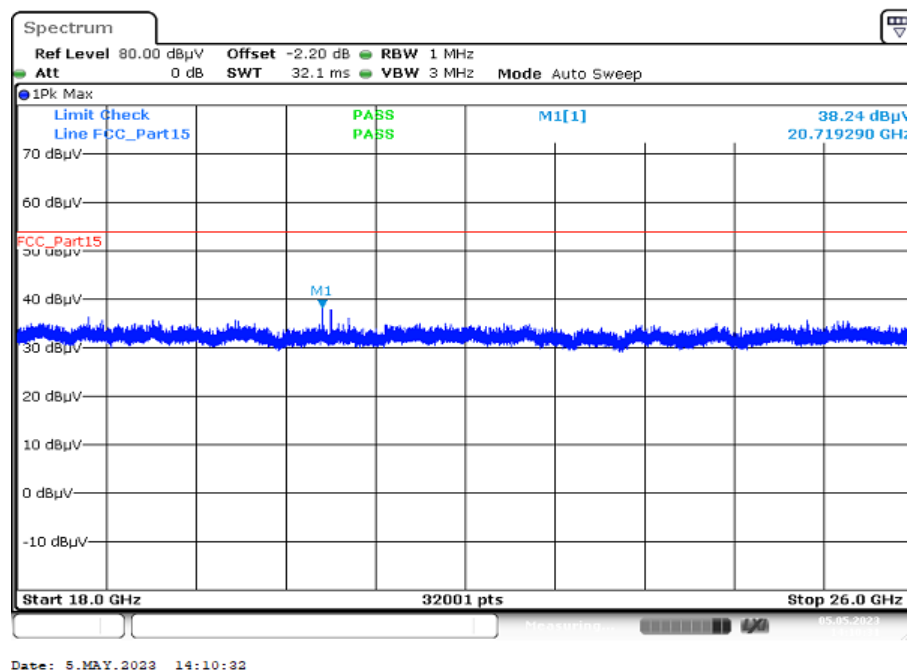
Plots: 20 MHz channel bandwidth nHT20-mode

Plot 10: 1 GHz to 18 GHz; vertical & horizontal polarization; U-NII-1; lowest channel



NOTE: The carrier is notched with a band rejection filter.

Plot 11: 18 GHz to 26 GHz; vertical & horizontal polarization; U-NII-1; lowest channel



MultiView Spectrum Spectrum 2

Ref Level 85.00 dBμV RBW 1 MHz

ATT 0 dB SW1 1.35 s VBW 3 MHz Mode Auto Sweep

TOP: HARQ637_C6/FLE502_CBL1_26_5-40G_0_5M_DBU/F

1 Frequency Sweep

Line Check PASS

Line LINE 54 DBU/F FCC PART 15.209 PASS

Line LINE 74 DBU/F FCC PART 15.209 PASS

LINE 14 DBU/F FCC PART 15.209

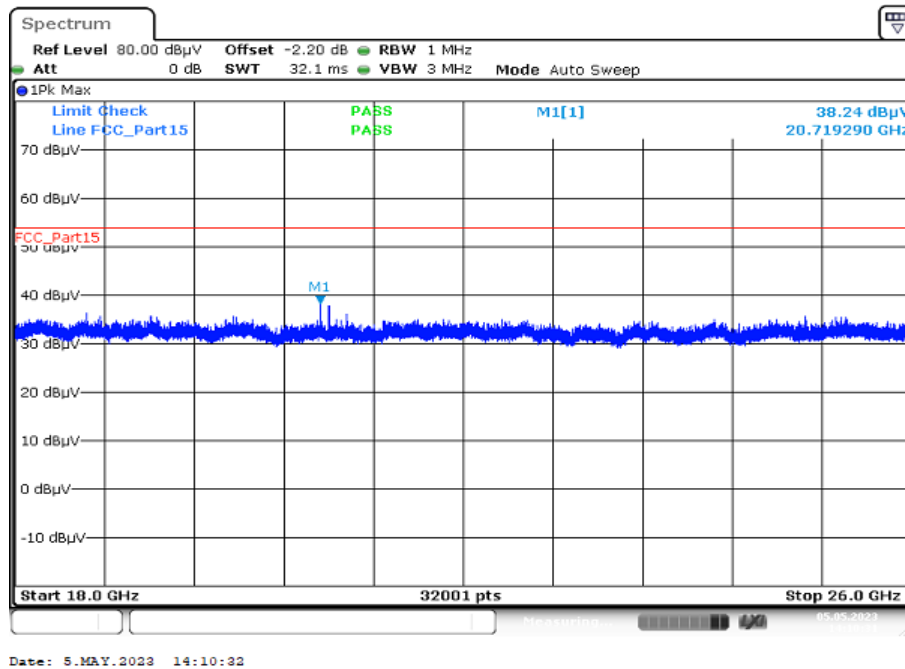
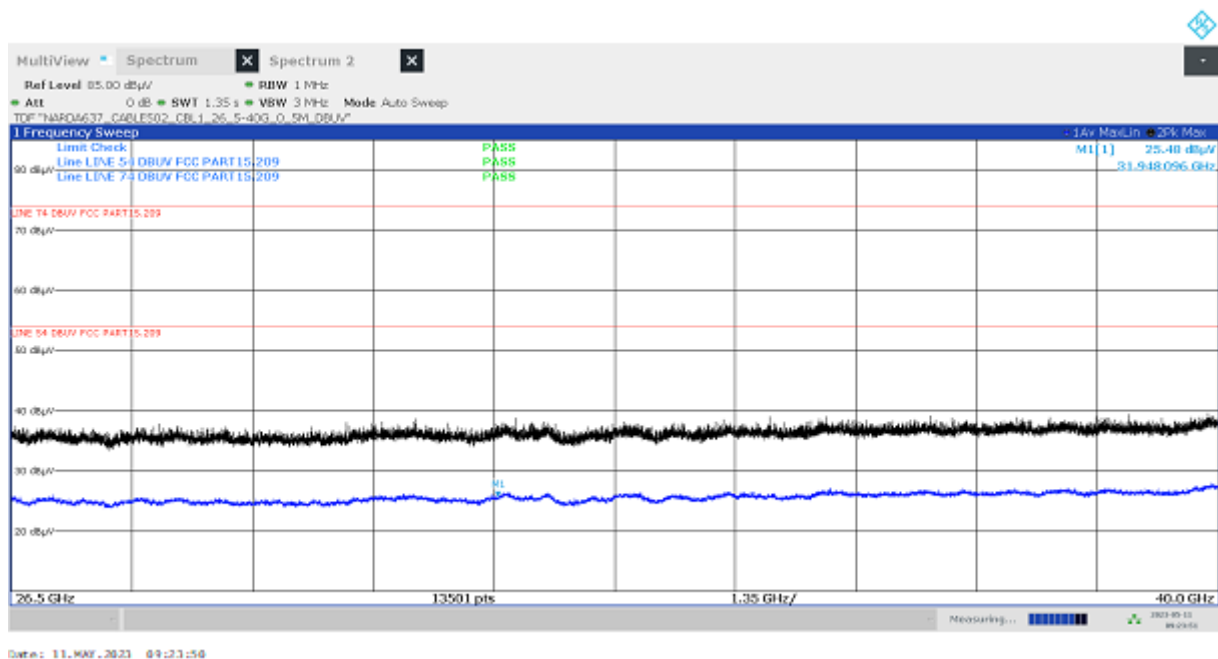
LINE 54 DBU/F FCC PART 15.209

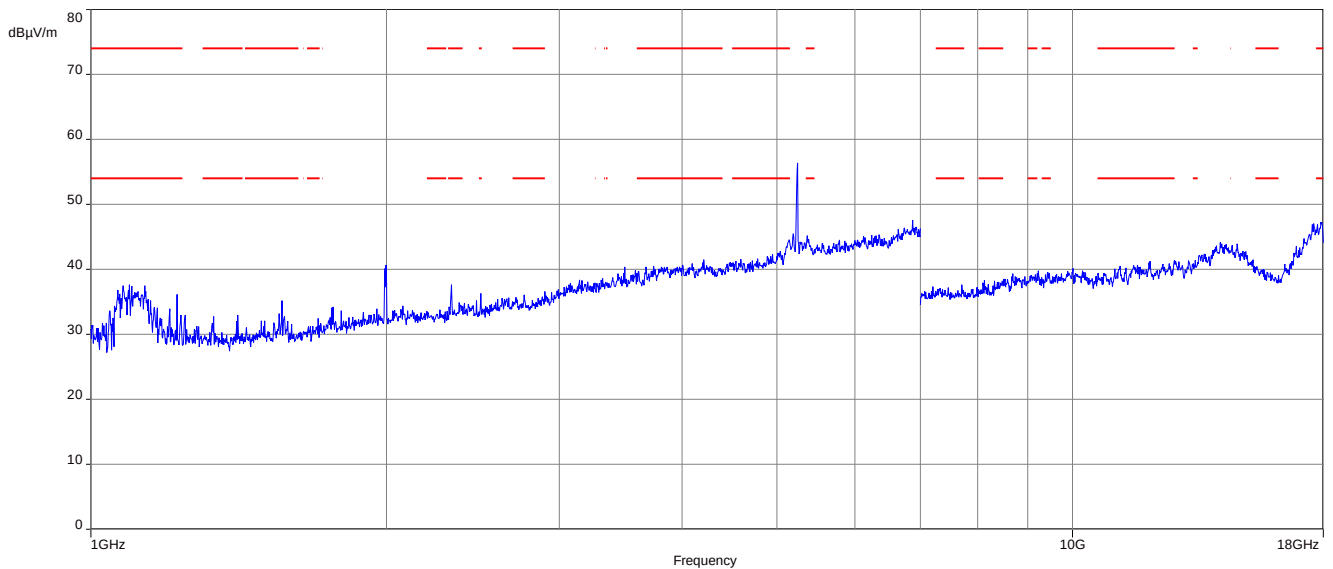
26.5 GHz 13501 pts 1.35 GHz/ 40.0 GHz

Measuring...

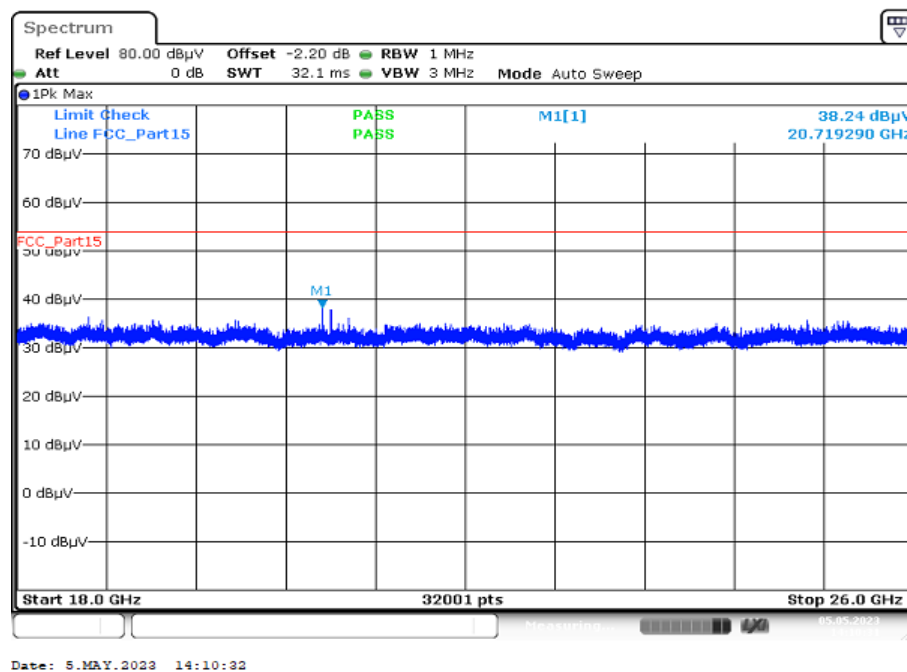
Date: 11/06/2023 09:23:50

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Plot 14: 18 GHz to 26 GHz; vertical & horizontal polarization; U-NII-1; middle channel**Plot 15:** 26 GHz to 40 GHz; vertical & horizontal polarization; U-NII-1; middle channel

Plot 16: 1 GHz to 18 GHz; vertical & horizontal polarization; U-NII-1; highest channel

NOTE: The carrier is notched with a band rejection filter.

Plot 17: 18 GHz to 26 GHz; vertical & horizontal polarization; U-NII-1; highest channel

[illegible]

12.12 Spurious emissions conducted < 30 MHz

Description:

Measurement of the conducted spurious emissions in transmit mode below 30 MHz. The EUT is set to middle channel. If critical peaks are found the lowest channel and the highest channel will be measured too. Both power lines, phase and neutral line, are measured. Found peaks are re-measured with average and quasi peak detection to show compliance to the limits.

Measurement:

Measurement parameter	
Detector:	Peak - Quasi Peak / Average
Sweep time:	Auto
Video bandwidth:	9 kHz
Resolution bandwidth:	100 kHz
Span:	150 kHz to 30 MHz
Trace mode:	Max Hold
Test setup:	See sub clause 7.5 – A
Measurement uncertainty:	See chapter 9

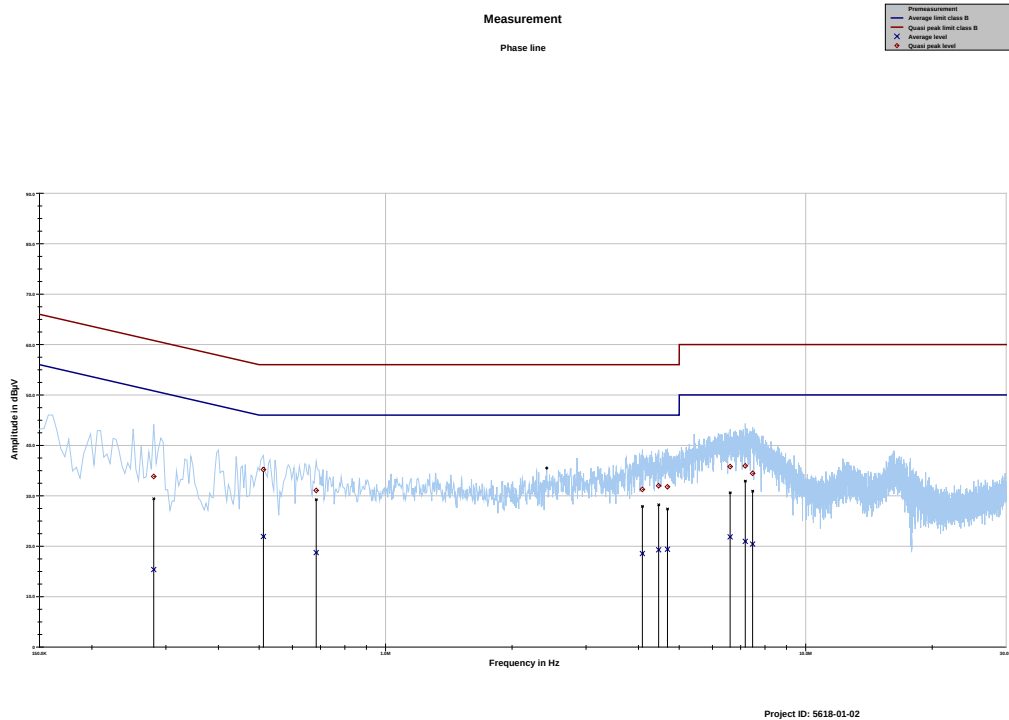
Limits:

Spurious Emissions Conducted < 30 MHz		
Frequency (MHz)	Quasi-Peak (dB μ V/m)	Average (dB μ V/m)
0.15 – 0.5	66 to 56*	56 to 46*
0.5 – 5	56	46
5 – 30.0	60	50

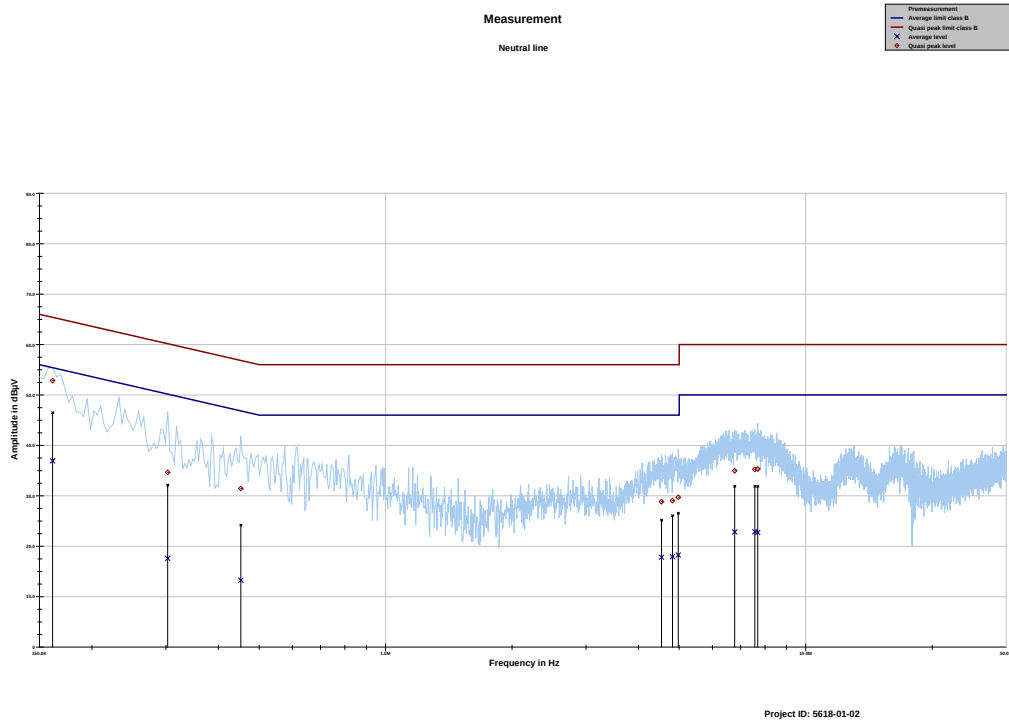
*Decreases with the logarithm of the frequency

Results:

Spurious Emissions Conducted < 30 MHz [dB μ V/m]		
F [MHz]	Detector	Level [dB μ V/m]
All detected emissions are more than 20 dB below the limit.		

Plots:**Plot 1:** 150 kHz to 30 MHz, phase line**Final results:**

Frequency	Quasi peak level	Margin quasi peak	Limit QP	Average level	Margin average	Limit AV
MHz	dBµV	dB	dBµV	dBµV	dB	dBµV
0.280594	33.83	26.97	60.798	15.37	36.90	52.269
0.511931	35.20	20.80	56.000	21.91	24.09	46.000
0.683569	31.07	24.93	56.000	18.72	27.28	46.000
4.086469	31.27	24.73	56.000	18.55	27.45	46.000
4.467056	31.99	24.01	56.000	19.29	26.71	46.000
4.687200	31.77	24.23	56.000	19.40	26.60	46.000
6.608794	35.78	24.22	60.000	21.84	28.16	50.000
7.179675	35.94	24.06	60.000	20.96	29.04	50.000
7.474444	34.45	25.55	60.000	20.44	29.56	50.000

Plot 2: 150 kHz to 30 MHz, neutral line**Final results:**

Frequency	Quasi peak level	Margin quasi peak	Limit QP	Average level	Margin average	Limit AV
MHz	dBµV	dB	dBµV	dBµV	dB	dBµV
0.161194	52.84	12.56	65.402	36.92	18.76	55.680
0.302981	34.65	25.51	60.161	17.59	34.04	51.629
0.452231	31.44	25.39	56.834	13.24	34.12	47.365
4.537950	28.82	27.18	56.000	17.80	28.20	46.000
4.817794	29.05	26.95	56.000	17.90	28.10	46.000
4.974506	29.70	26.30	56.000	18.25	27.75	46.000
6.776700	34.96	25.04	60.000	22.83	27.17	50.000
7.567725	35.23	24.77	60.000	22.88	27.12	50.000
7.687125	35.30	24.70	60.000	22.73	27.27	50.000

13 Observations

No observations except those reported with the single test cases have been made.

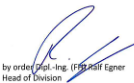
14 Glossary

EUT	Equipment under test
DUT	Device under test
UUT	Unit under test
FCC	Federal Communications Commission
FCC ID	Company Identifier at FCC
IC	Industry Canada
PMN	Product marketing name
HMN	Host marketing name
HVIN	Hardware version identification number
FVIN	Firmware version identification number
EMC	Electromagnetic Compatibility
HW	Hardware
SW	Software
Inv. No.	Inventory number
S/N or SN	Serial number
C	Compliant
NC	Not compliant
NA	Not applicable
NP	Not performed
PP	Positive peak
QP	Quasi peak
AVG	Average
OC	Operating channel
OCW	Operating channel bandwidth
OBW	Occupied bandwidth
OOB	Out of band
DFS	Dynamic frequency selection
CAC	Channel availability check
OP	Occupancy period
NOP	Non occupancy period
DC	Duty cycle
PER	Packet error rate
CW	Clean wave
MC	Modulated carrier
WLAN	Wireless local area network
RLAN	Radio local area network
DSSS	Dynamic sequence spread spectrum
OFDM	Orthogonal frequency division multiplexing
FHSS	Frequency hopping spread spectrum

15 Document history

Version	Applied changes	Date of release
-/-	Initial release	2023-05-17

16 Accreditation Certificate – D-PL-12076-01-04

first page	last page
 Deutsche Akkreditierungsstelle GmbH Entrusted according to Section 8 subsection 1 AkkStelleG in connection with Section 1 subsection 1 AkkStelleGBV Signatory to the Multilateral Agreements of EA, ILAC and IAF for Mutual Recognition Accreditation  The Deutsche Akkreditierungsstelle GmbH attests that the testing laboratory CTC advanced GmbH Untertürkheimer Straße 6-10, 66117 Saarbrücken is competent under the terms of DIN EN ISO/IEC 17025:2018 to carry out tests in the following fields: Telecommunication (TC) and Electromagnetic Compatibility (EMC) for Canadian Standards The accreditation certificate shall only apply in connection with the notice of accreditation of 09.06.2020 with the accreditation number D-PL-12076-01. It comprises the cover sheet, the reverse side of the cover sheet and the following annex with a total of 07 pages. Registration number of the certificate: D-PL-12076-01-04 Frankfurt am Main, 09.06.2020 by order:  Prof.-Ing. (FH) Ralf Egner Head of Division The certificate together with its annex reflects the status at the time of the date of issue. The current status of the scope of accreditation can be found in the database of accredited bodies of Deutsche Akkreditierungsstelle GmbH. https://www.dakks.de/en/content/accredited-bodies-dakks See notes overleaf.	Deutsche Akkreditierungsstelle GmbH Office Berlin Spittelmarkt 10 10117 Berlin Office Frankfurt am Main Europa-Allee 52 60327 Frankfurt am Main Office Braunschweig Bundesallee 100 38116 Braunschweig The publication of extracts of the accreditation certificate is subject to the prior written approval by Deutsche Akkreditierungsstelle GmbH (DAKKS). Exempted is the unchanged form of separate disseminations of the cover sheet by the conformity assessment body mentioned overleaf. No impression shall be made that the accreditation also extends to fields beyond the scope of accreditation attested by DAKKS. The accreditation was granted pursuant to the Act on the Accreditation Body (AkkStelleG) of 31 July 2009 (Federal Law Gazette I p. 2625) and the Regulation (EC) No 765/2008 of the European Parliament and of the Council of 9 July 2008 setting out the requirements for accreditation and market surveillance relating to the marketing of products (Official Journal of the European Union L 218 of 9 July 2008, p. 30). DAKKS is a signatory to the Multilateral Agreements for Mutual Recognition of the European co-operation for Accreditation (EA), International Accreditation Forum (IAF) and International Laboratory Accreditation Cooperation (ILAC). The signatories to these agreements recognise each other's accreditations. The up-to-date state of membership can be retrieved from the following websites: EA: www.european-accreditation.org ILAC: www.ilac.org IAF: www.iaf.nu

Note: The current certificate annex is published on the websites (link see below).

<https://www.dakks.de/files/data/as/pdf/D-PL-12076-01-04e.pdf>

or

https://cetecomadvanced.com/files/pdfs/d-pl-12076-01-04_canada_tcemc.pdf

17 Accreditation Certificate – D-PL-12076-01-05

first page	last page			
 Deutsche Akkreditierungsstelle GmbH Entrusted according to Section 8 subsection 1 AkkStelleG in connection with Section 1 subsection 1 AkkStelleGBV Signatory to the Multilateral Agreements of EA, ILAC and IAF for Mutual Recognition Accreditation  The Deutsche Akkreditierungsstelle GmbH attests that the testing laboratory CTC advanced GmbH Untertürkheimer Straße 6-10, 66117 Saarbrücken is competent under the terms of DIN EN ISO/IEC 17025:2018 to carry out tests in the following fields: Telecommunication (FCC Requirements) The accreditation certificate shall only apply in connection with the notice of accreditation of 09.06.2020 with the accreditation number D-PL-12076-01. It comprises the cover sheet, the reverse side of the cover sheet and the following annex with a total of 05 pages. Registration number of the certificate: D-PL-12076-01-05 Frankfurt am Main, 09.06.2020  by order: Dipl.-Ing. (FH) Ingrid Egner Head of Division The certificate together with its annex reflects the status at the time of the date of issue. The current status of the scope of accreditation can be found in the database of accredited bodies of Deutsche Akkreditierungsstelle GmbH. https://www.dakks.de/en/content/accredited-bodies-dakks See notes attached.	Deutsche Akkreditierungsstelle GmbH <table><tr><td>Office Berlin Spittelmarkt 10 10117 Berlin</td><td>Office Frankfurt am Main Europa-Allee 52 60327 Frankfurt am Main</td><td>Office Braunschweig Bundesallee 100 38116 Braunschweig</td></tr></table> The publication of extracts of the accreditation certificate is subject to the prior written approval by Deutsche Akkreditierungsstelle GmbH (DAKKS). Exempted is the unchanged form of separate disseminations of the cover sheet by the conformity assessment body mentioned overleaf. No impression shall be made that the accreditation also extends to fields beyond the scope of accreditation attested by DAKKS. The accreditation was granted pursuant to the Act on the Accreditation Body (AkkStelleG) of 31 July 2009 (Federal Law Gazette I p. 2625) and the Regulation (EC) No 765/2008 of the European Parliament and of the Council of 9 July 2008 setting out the requirements for accreditation and market surveillance relating to the marketing of products (Official Journal of the European Union L 218 of 9 July 2008, p. 30). DAKKS is a signatory to the Multilateral Agreements for Mutual Recognition of the European co-operation for Accreditation (EA), International Accreditation Forum (IAF) and International Laboratory Accreditation Cooperation (ILAC). The signatories to these agreements recognise each other's accreditations. The up-to-date state of membership can be retrieved from the following websites: EA: www.european-accreditation.org ILAC: www.ilac.org IAF: www.iaf.nu	Office Berlin Spittelmarkt 10 10117 Berlin	Office Frankfurt am Main Europa-Allee 52 60327 Frankfurt am Main	Office Braunschweig Bundesallee 100 38116 Braunschweig
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<https://www.dakks.de/files/data/as/pdf/D-PL-12076-01-05e.pdf>

or

https://cetecomadvanced.com/files/pdfs/d-pl-12076-01-05_tcb_usa.pdf

END OF TEST REPORT